

# X-ray Free Electron Laser Part-2 Photon Beamline and Experiments

*XFEL Utilization Division, JASRI*

Kensuke Tono

# Contents

1. XFEL sciences
2. Photon beam properties
3. Photon beamline
4. Experimental stations
5. Experiments at SACLA

# Contents

- 1. XFEL sciences**
2. Photon beam properties
3. Photon beamline
4. Experimental stations
5. Experiments at SACLA

# XFEL properties and sciences

- Short pulse (<10 fs)
- High peak power (>30 GW)
- Coherent

## *Ultrafast observation beyond the speed of atomic motion*

- Beyond static image
  - Imaging functions (motion pictures of chemical reaction, phase transition, etc.)
- Beyond statistical image
  - Imaging fluctuations, rare events

## *Ultrahigh intensity opens new regime of X-ray-matter interactions*

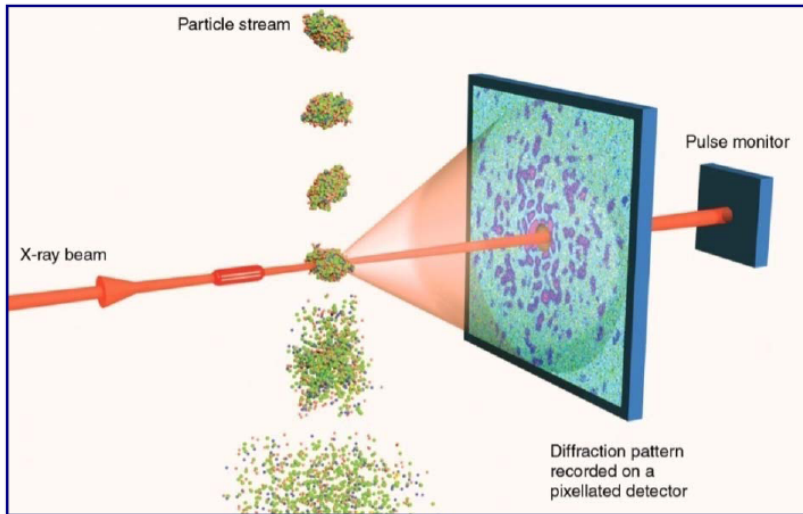
- Beyond linear response



(Image from Wikipedia)

# Ultrafast observation “See before destruction”

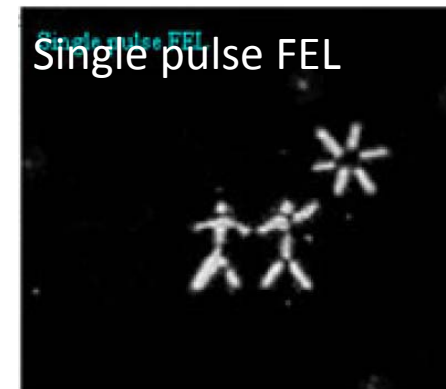
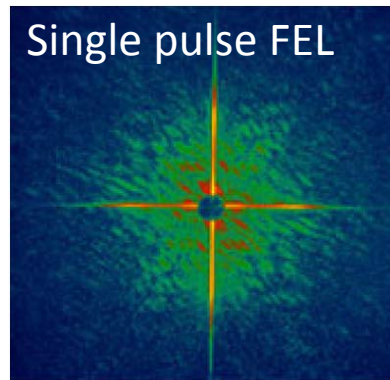
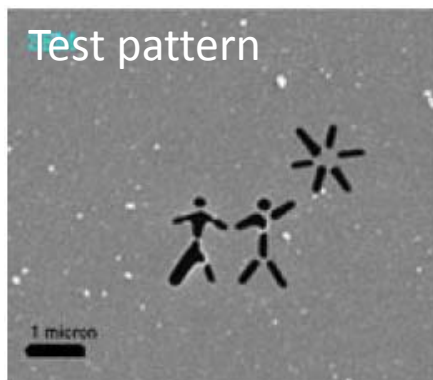
- **Single-shot imaging**



1. See before damaged
2. New shots on new samples
3. Ensemble of 3D orientations
4. Time resolved ( $\sim 10$ fs):  
pump-probe imaging  
(conformational change,  
reaction process?)

Images from  
H.Chapman, *Science* ('07)

First demonstration at FLASH



Chapman et al., *Nature Physics* **2**, 839 (2006)

# Femtosecond snapshot of a *live* cell



ARTICLE

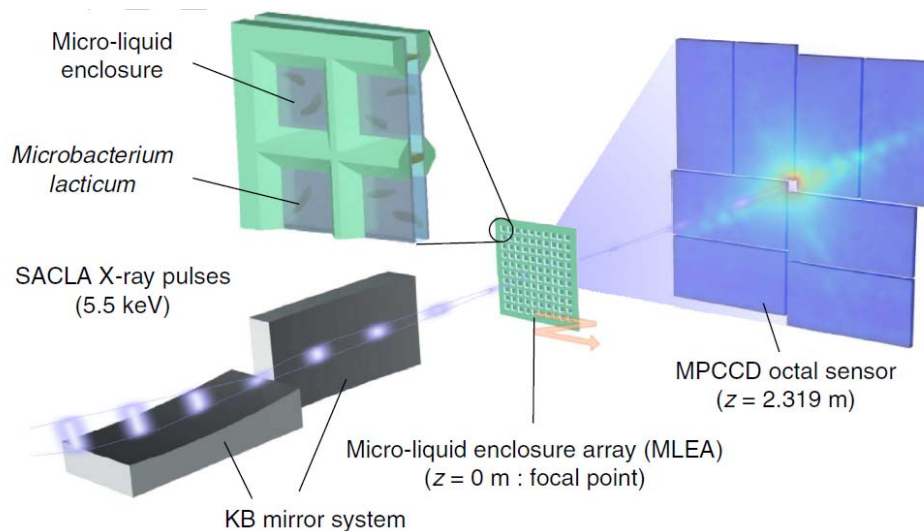
Received 17 Jul 2013 | Accepted 2 Dec 2013 | Published xx xxx 2013

DOI: 10.1038/ncomms4052

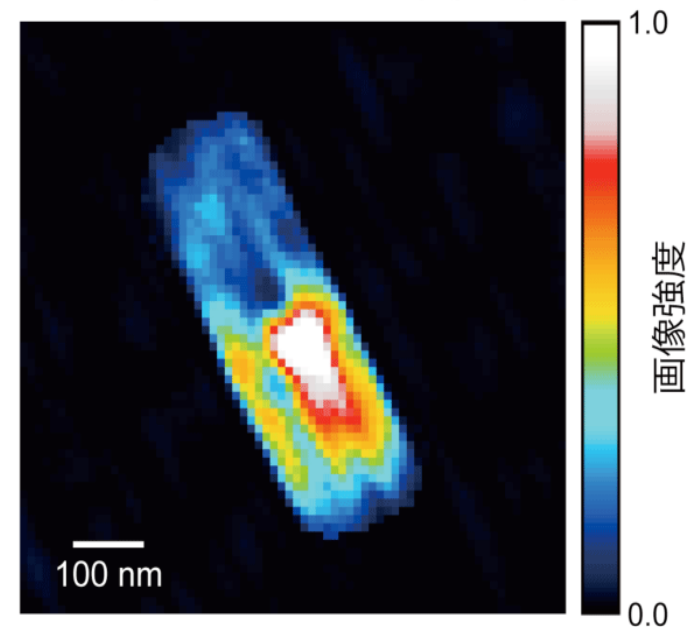
OPEN

## Imaging live cell in micro-liquid enclosure by X-ray laser diffraction

Kimura et al., *Nature Communications* 5, 3052 (2013).



XFELで観察した生きている細胞の画像



# High intensity application

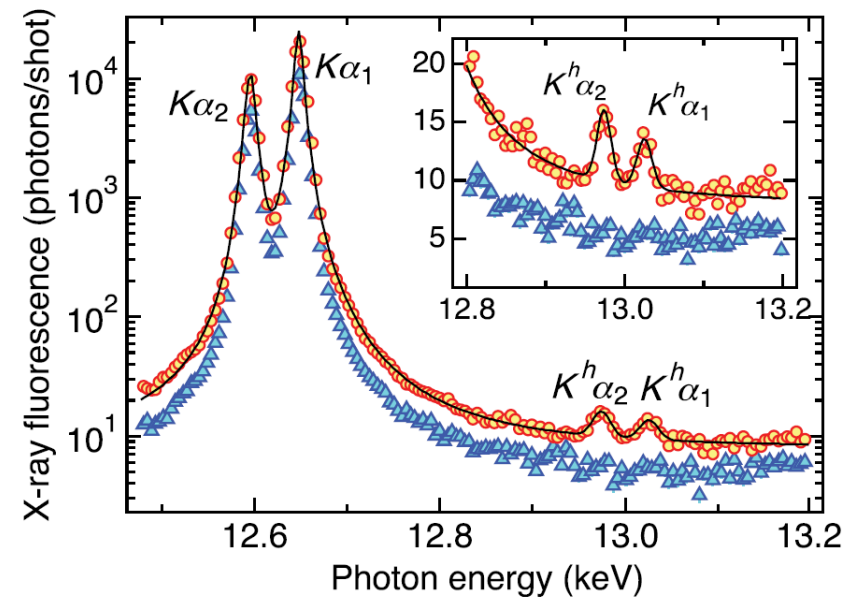
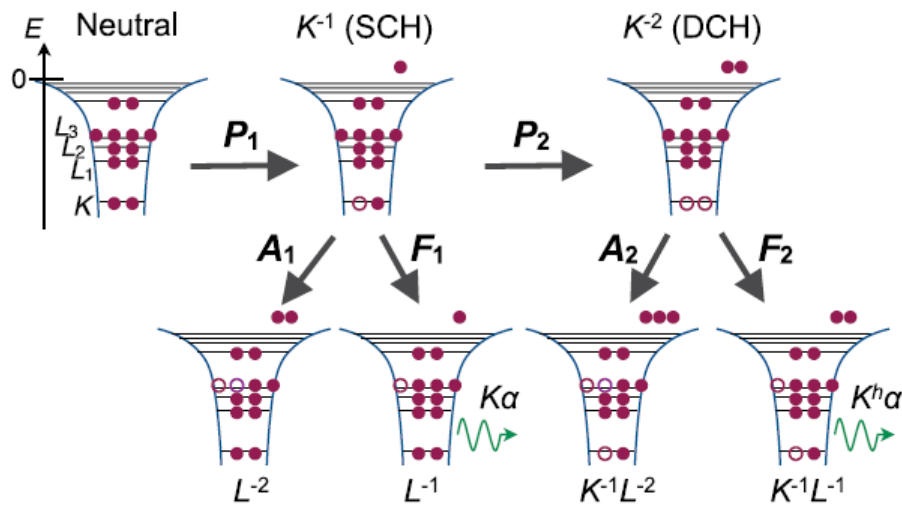
K. Tamasaku et al, PRL Vol.111 (2013)

## Emission from double core hole atoms

1  $\mu\text{m}$  focusing

- 100  $\mu\text{J}/10\text{ fs} = 10\text{ GW}$  (after 1- $\mu\text{m}$  KB)
- Focusing size:  $\sim 1 \times 1\ \mu\text{m}^2$
- $10\text{ GW}/(1\ \mu\text{m})^2 \sim 10^{18}\text{ W/cm}^2$

### Double core hole of Kr



# Contents

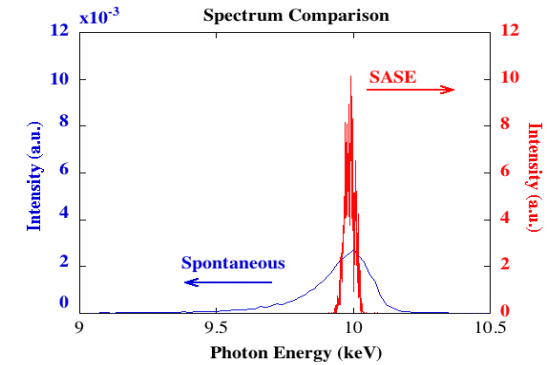
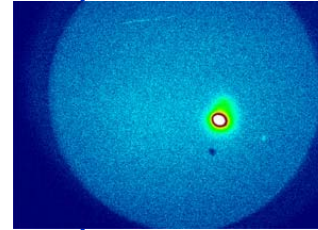
1. XFEL sciences
- 2. Photon beam properties**
3. Photon beamline
4. Experimental stations
5. Experiments at SACLA



# Properties of **SASE** XFEL beam

## Low emittance & short pulse

- Source size  $\sim 30 \mu\text{m}@10 \text{ keV}$
- Divergence  $\sim 2 \mu\text{rad}@10 \text{ keV}$
- Bandwidth  $\sim 5 \times 10^{-3}$
- Pulse duration  $< 10 \text{ fs}$

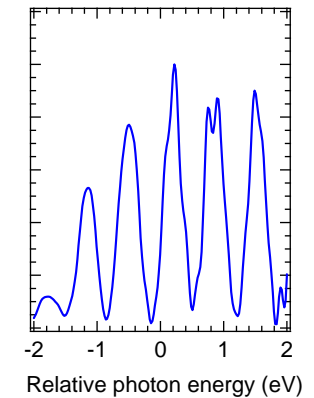
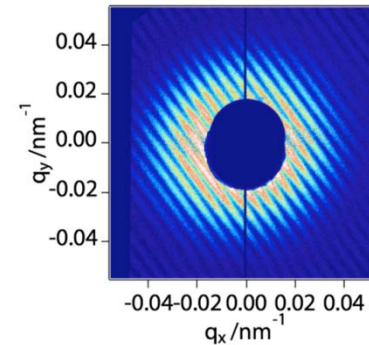


## Coherent

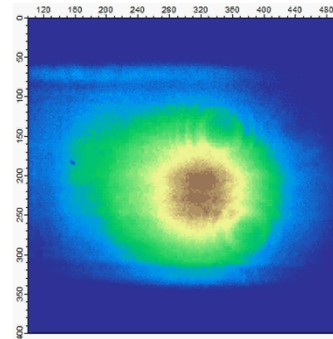
- Transverse only
- Multimode in longitudinal

## High intensity

- Pulse energy  $\sim 0.5 \text{ mJ}@10 \text{ keV}$   
( $\sim 3 \times 10^{11}$  photons)
- Peak power  $> 50 \text{ GW}@10 \text{ keV}$

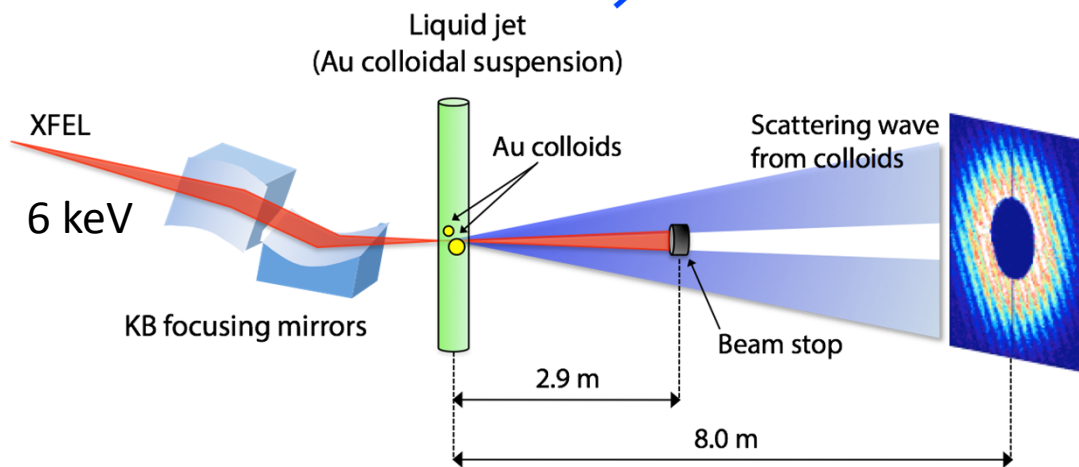
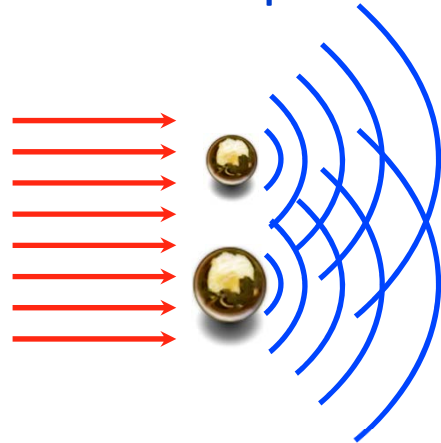


## Shot-by-shot fluctuation

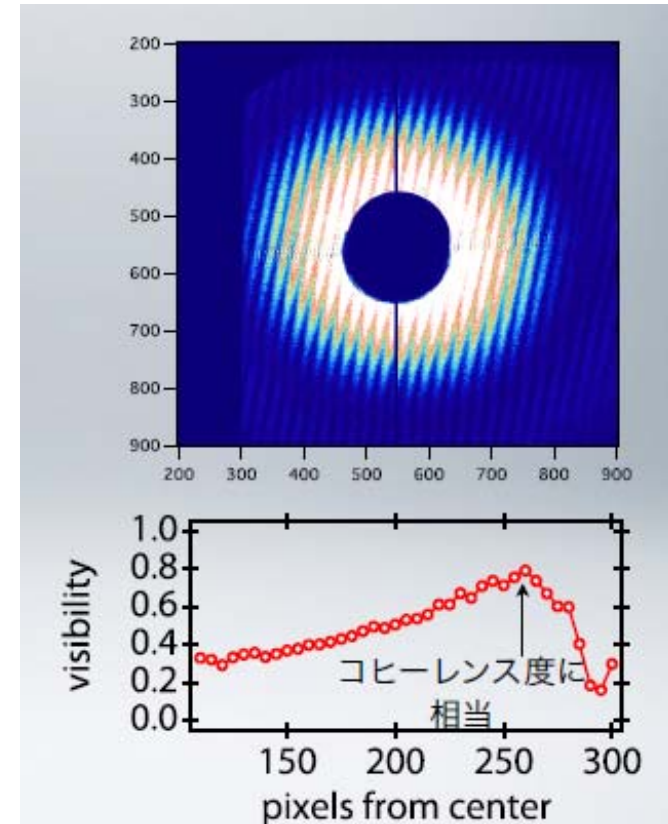
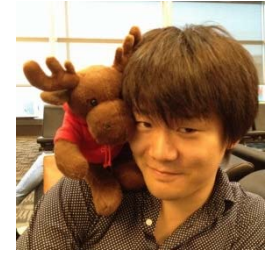


# Coherent (transverse only)

Interference between scattering waves from two particles



Inoue (U. Tokyo) et al.,  
in preparation

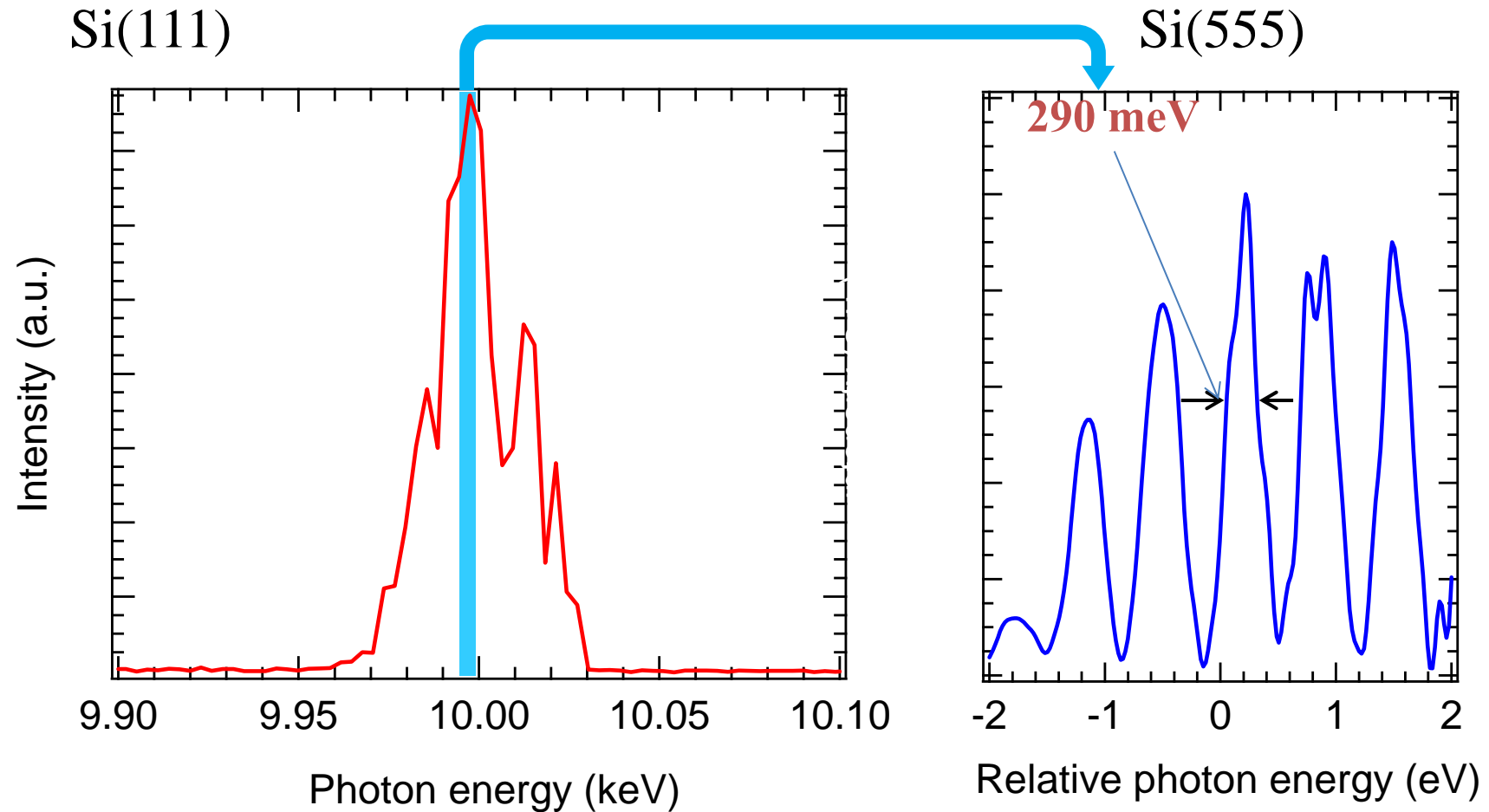


Total degree of coherence:  $\sim 0.6$

$\sim 80\%$  of the total power is in the dominant mode ( $\text{TEM}_{00}$ )

# Multimode

Spectrum of single XFEL pulse consists of thousands of spikes due to multi optical modes.

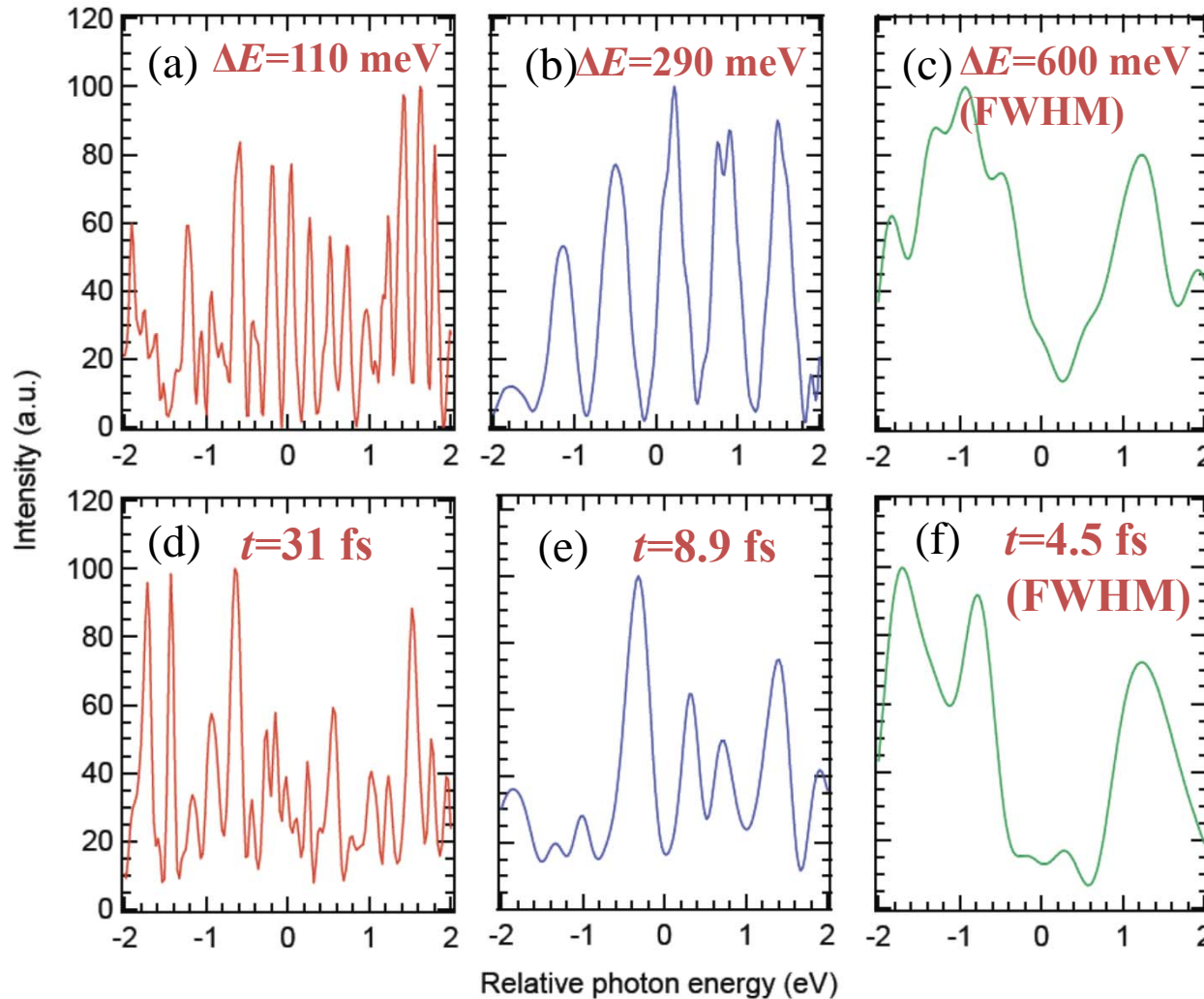


# Spectra at different pulse durations

Inubushi (JASRI) et al.  
PRL 109, 144801 (2012)



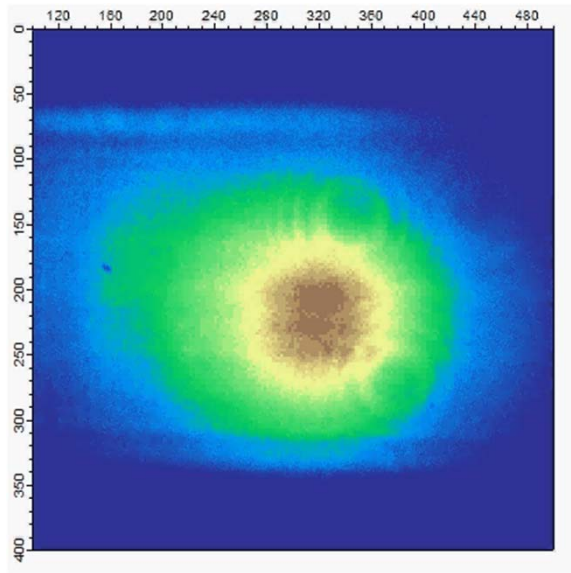
Measured Spectra



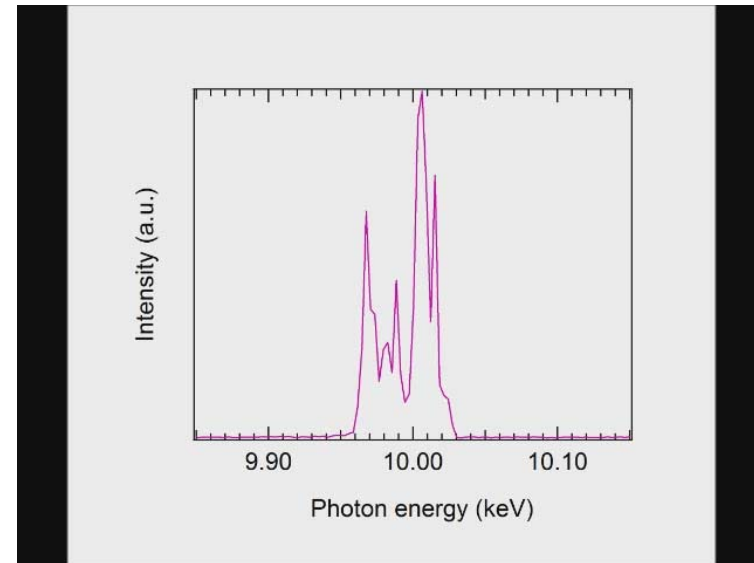
Simulated spectra

# Shot-by-shot fluctuation

Intensity/position



Spectrum



Photon-beam parameters and experimental data should be collected in a shot-by-shot manner.

# Contents

1. XFEL sciences
2. Photon beam properties
- 3. Photon beamline**
4. Experimental stations
5. Experiments at SACLA

# Design concept

- **Main optics & diagnostics** are centralized in Optics Hutch
  - > Transport & online diagnostics of a photon beam with low emittance, short pulse, and high coherence.
  - > Fine electron-beam tuning with X-ray optics & diagnostics.
- Experimental stations provide only basic infrastructure (e.g., optical laser, focusing system)
  - > Enough space for various experimental instruments

# SACLA Photon Beamline

BL1: SX  
BL2: HX (From 2015)  
BL3: HX

OH: Common optics & diagnostics

EH1: Beam diagnostics  
(Spectrum, timing)

EH2: Pump & Probe  
w/ unfocused beam

EH3: 1- $\mu$ m focusing  
(Imaging, crystallography)

EH4: 1- $\mu$ m focusing  
(Nonlinear,  
Pump & Probe)

Laser booth  
(CPA, OPA)

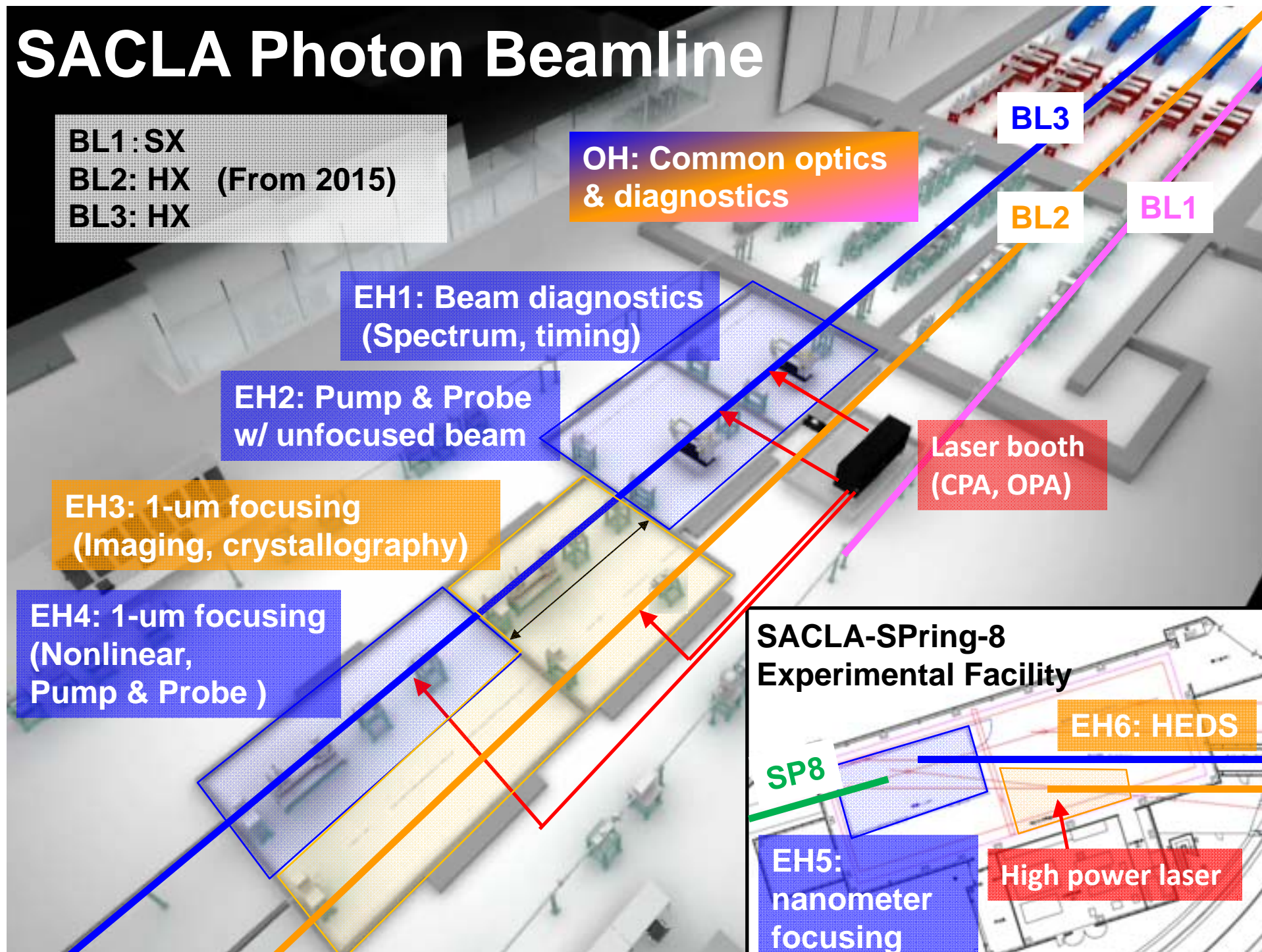
SACLA-SPring-8  
Experimental Facility

EH6: HEDS

SP8

EH5:  
nanometer  
focusing

High power laser

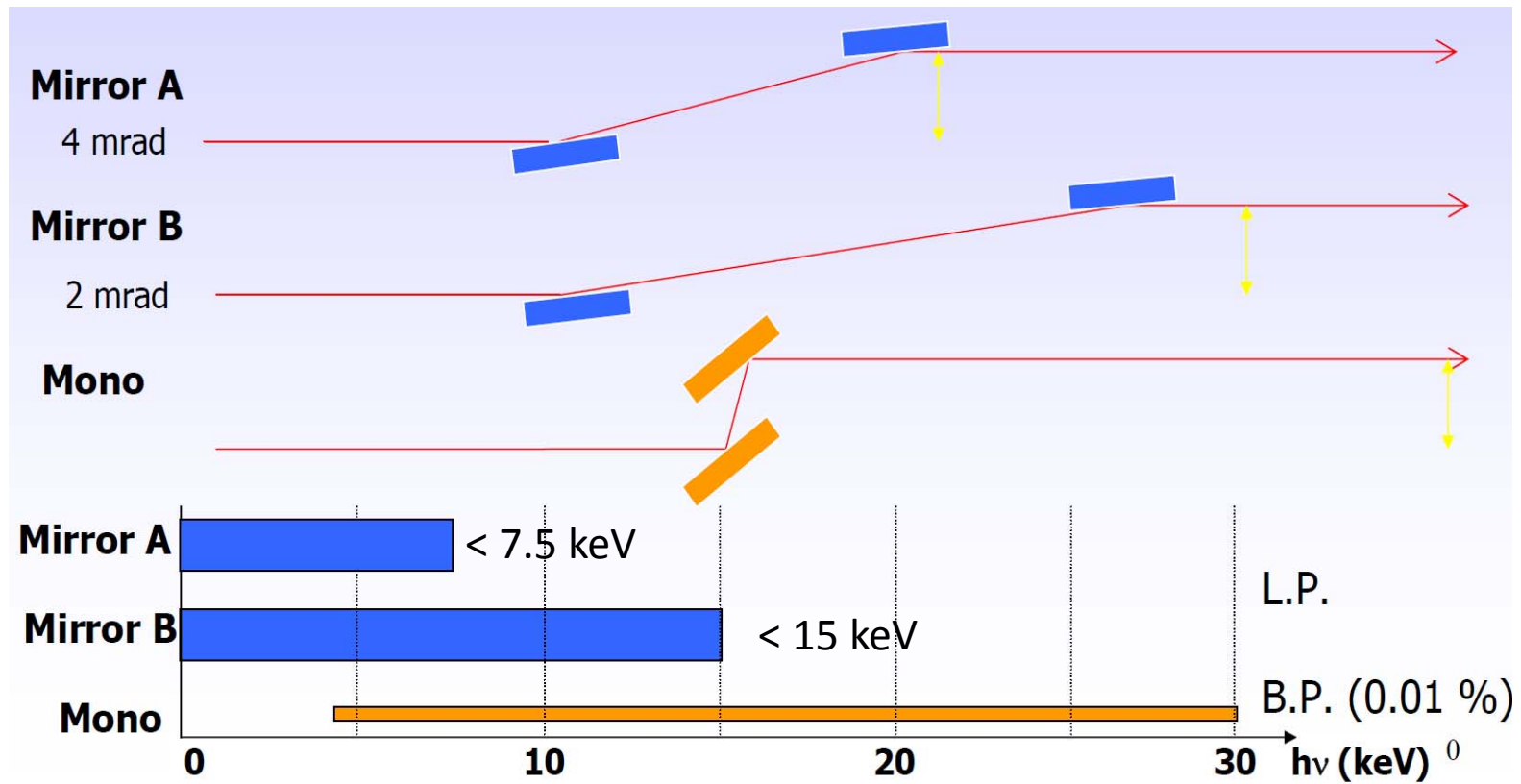




# Beamline optics

Transport XFEL beam & filter out unnecessary lights

- Double plane mirrors (2 sets): Low-pass filter (Bandwidth of output beam  $\sim 5 \times 10^{-3}$ )
- Double crystal monochromator (DCM, Si 111): Band-pass filter ( $\sim 1 \times 10^{-4}$ )



# Optical elements for XFEL

XFEL features	Demands
Short pulse (<10 fs)	Damage free
High peak power (>30 GW)	
Coherent	Speckle free

## Damage on a mirror material

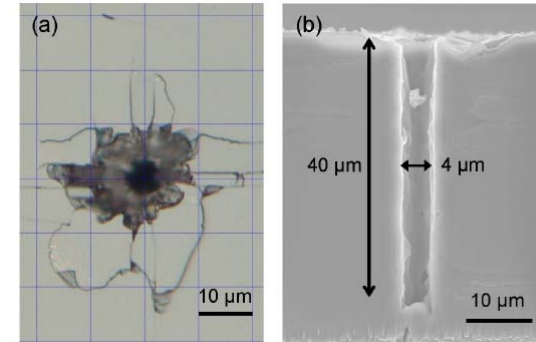
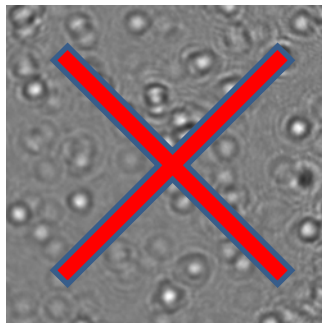


Fig. 2. (a) Optical microscope image of irradiated silicon viewed from surface at fluence of  $57 \mu\text{J}/\mu\text{m}^2$ . (b) Cross sectional SEM image of (a) prepared by focused ion beam sampling.

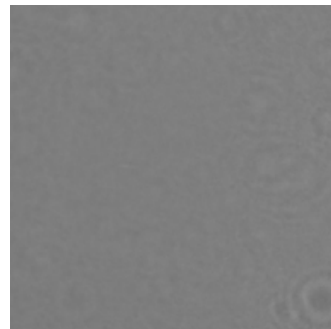
Koyama et al., Opt. Exp. 21 (2013)

Typical Be window



Goto et al., Proc. of SPIE 6705 (2007)

Speckle-free Be window



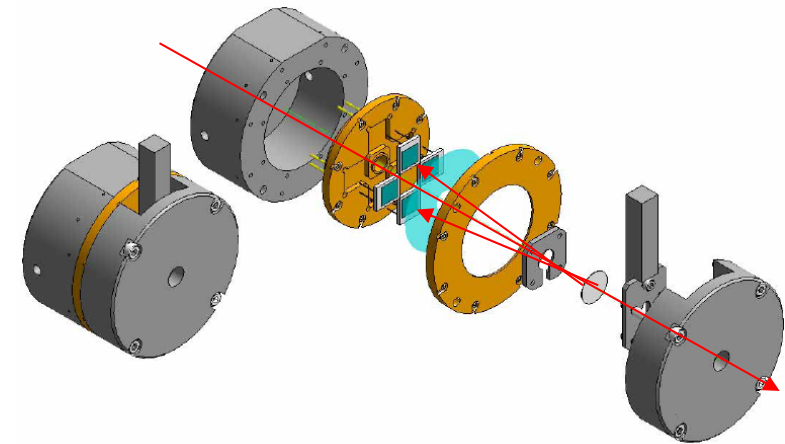
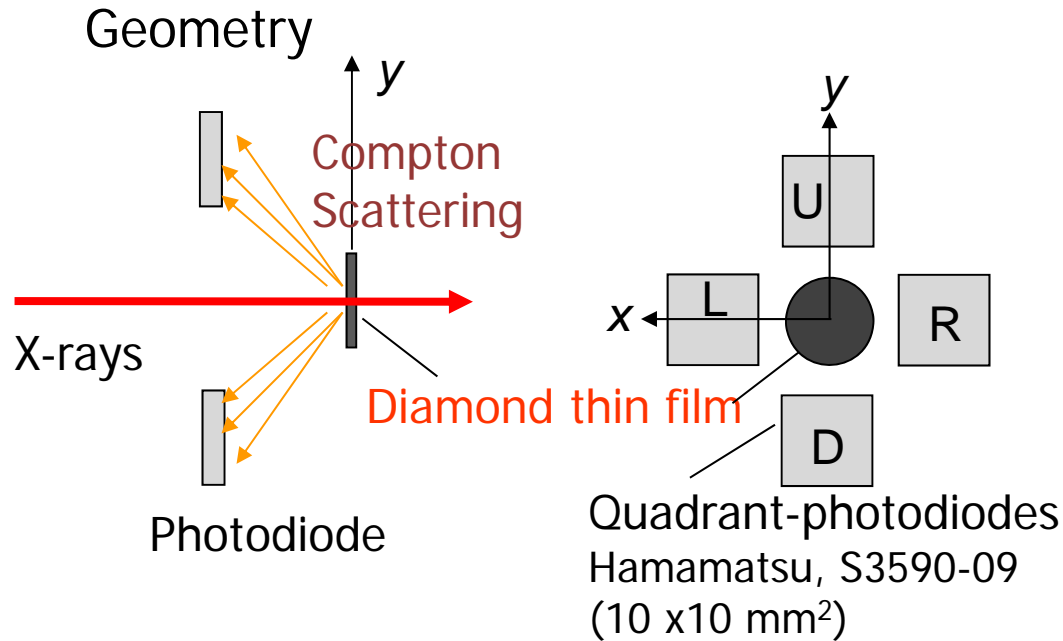
Ultraprecise mirror finished by Elastic Emission Machining



Mimura et al., Rev. Sci. Instrum. **79**, (2008)

# On-line photon diagnostics: Beam monitor (intensity/position)

K. Tono et al. *RSI* 82, 023108 (2011)

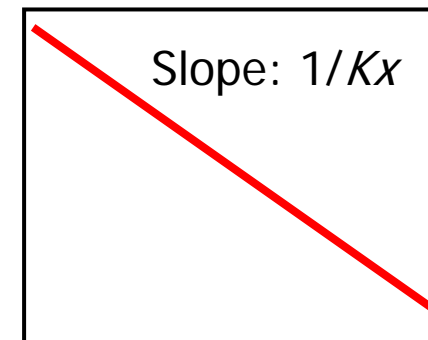


Intensity  $I \propto (I_L + I_R + I_U + I_D)$

Position  $x = K_x \frac{I_L - I_R}{I_L + I_R} = K_x \Delta I_x$

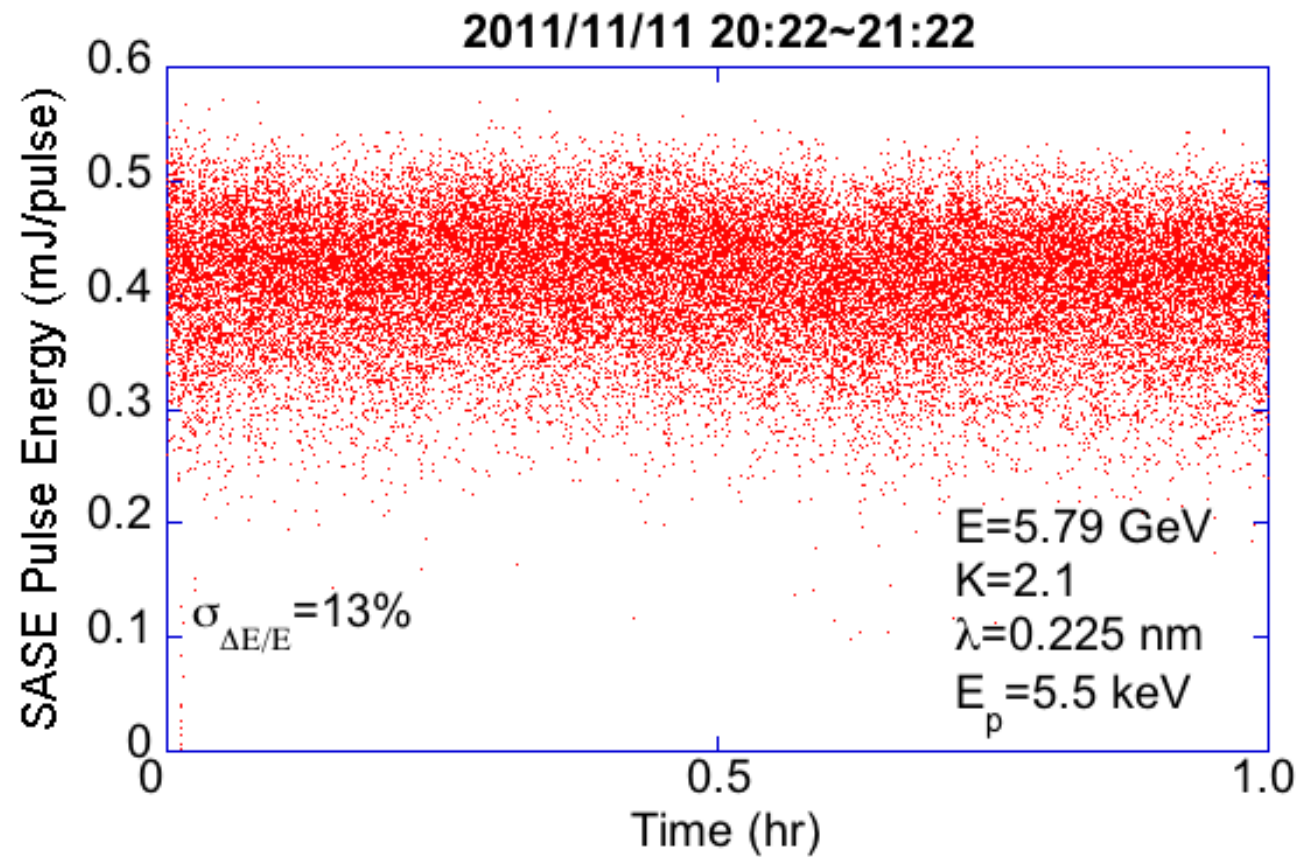
$$y = K_y \frac{I_U - I_D}{I_U + I_D} = K_y \Delta I_y$$

$\Delta I_x$

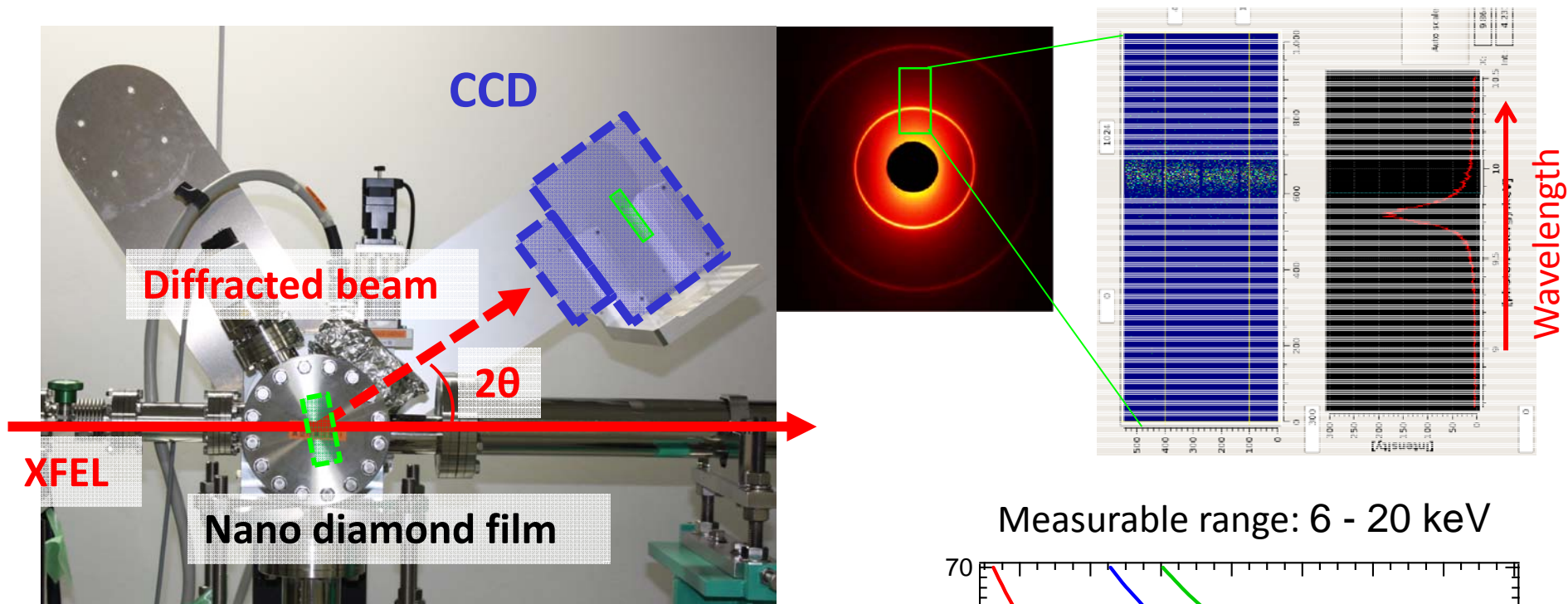


Alkire et al., *J. Syn. Rad.* 7, 61 (2000).<sup>19</sup>

# Shot-by-shot measurement of pulse energy



# Wavelength (photon-energy) monitor

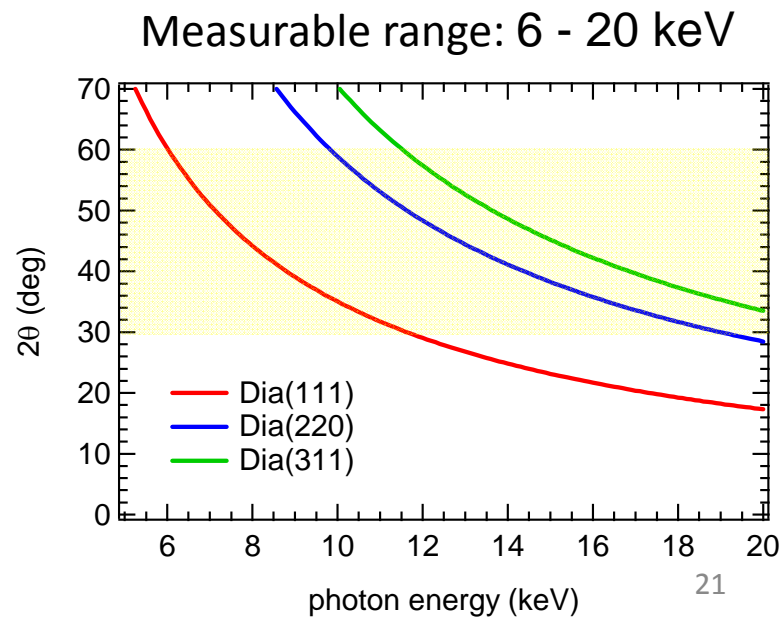


Wavelengths ( $\lambda$ ) are calculated from positions of Debye-Scherrer rings on MPCCD.

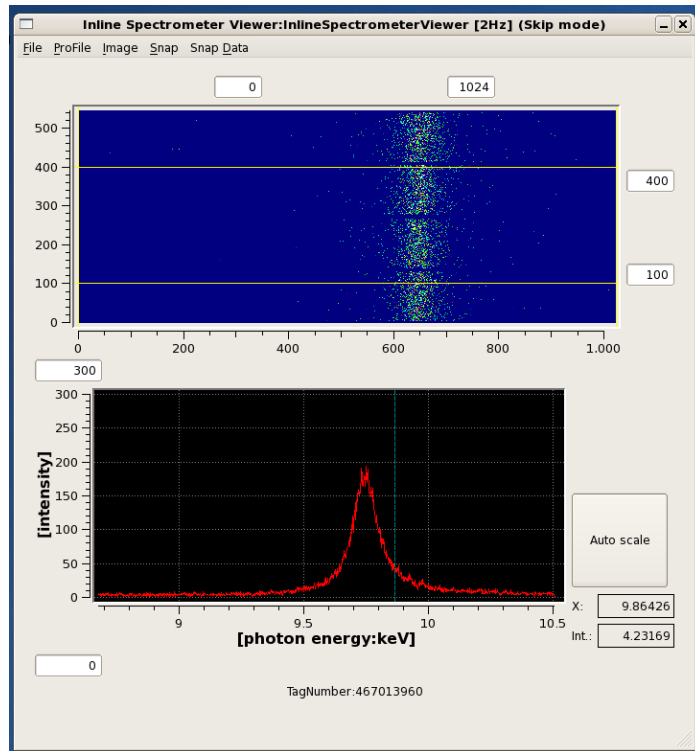
$$2d\sin\theta = n\lambda$$



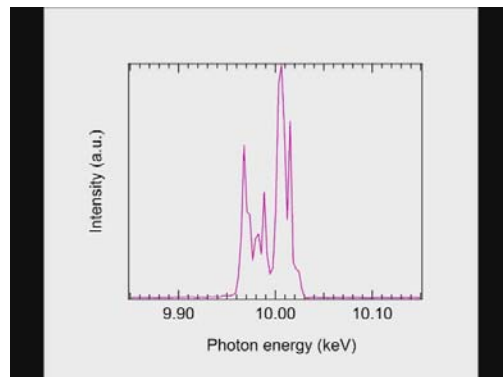
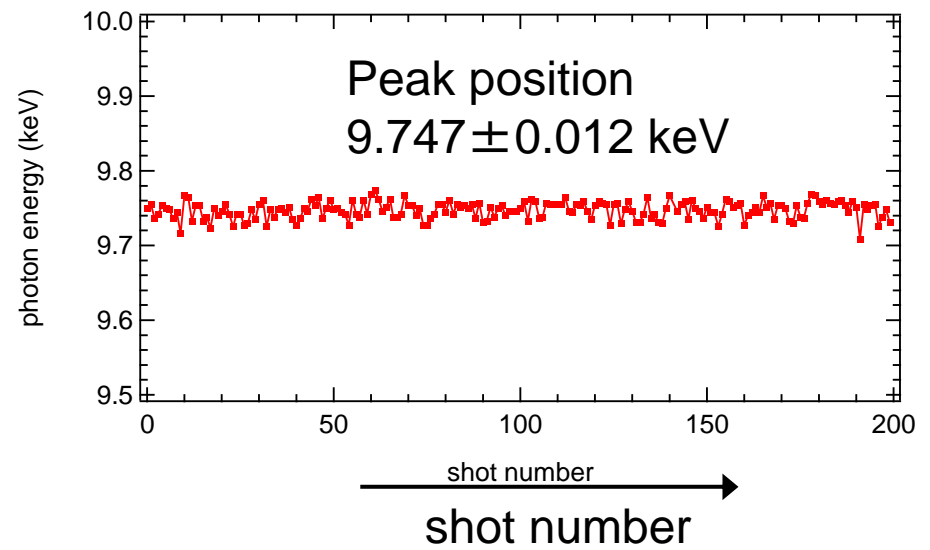
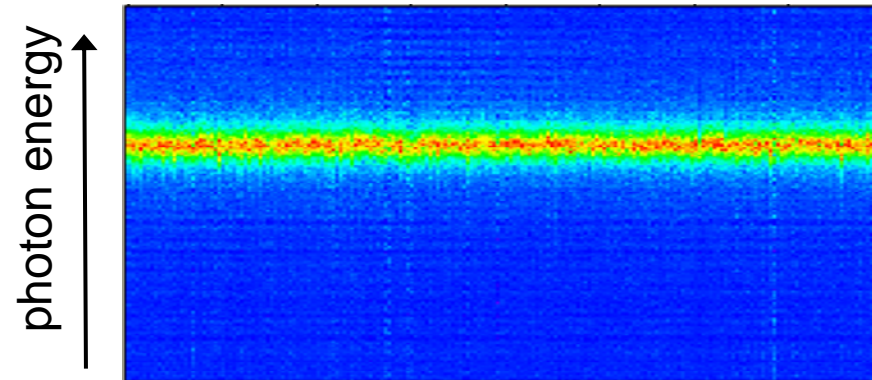
Inubushi -san



# Shot-by-shot measurement



Trend

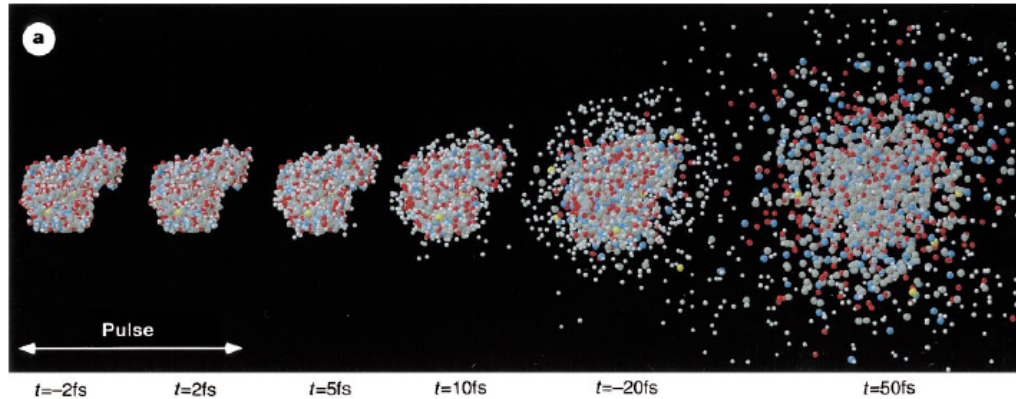


# Contents

1. XFEL sciences
2. Photon beam properties
3. Photon beamline
- 4. Experimental stations**
5. Experiments at SACLA

# Single-shot measurement is mandatory.

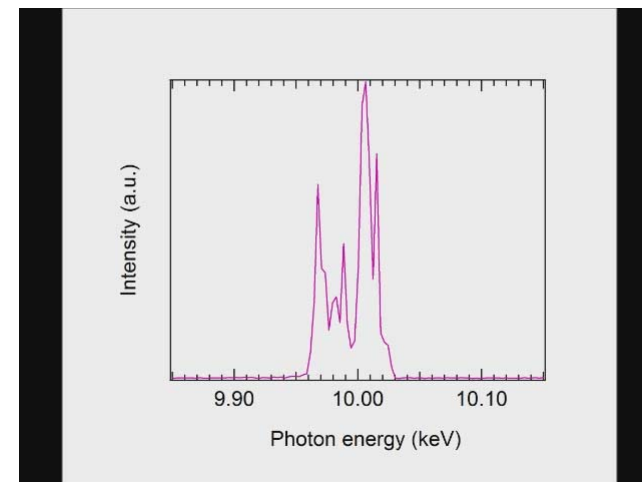
- Even a single pulse destroys a sample.



Neutze et al., Nature 406,  
752 (2000)

- Pulse-by-pulse fluctuation of XFEL pulses.

Difficult to repeat measurement  
in the same condition.



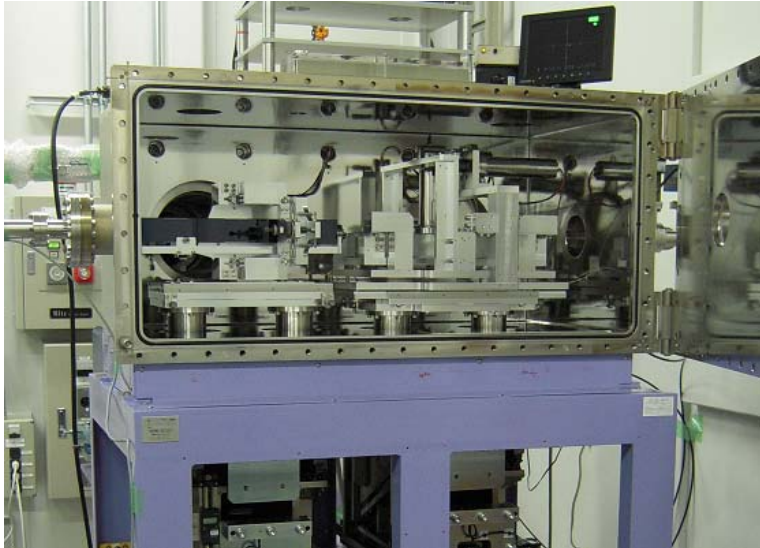


# Instrumentation for single-shot measurement

- **High photon flux**
  - Focusing
- **Fast sample exchange**
  - Injectors
  - Fixed targets with a fast scanning system
- **Fast & sensitive X-ray detection**
  - High performance detectors
    - ✓ High sensitivity, high frame rate, high dynamic range, large area, ...
- **Fast & reliable data acquisition (DAQ)**
  - High performance computers
  - High speed network
  - Large storage system

# Focusing

## 1-um focusing mirrors



Yumoto et al Nature Photon. 7, 43 (2013)

nature  
photonics

LETTERS

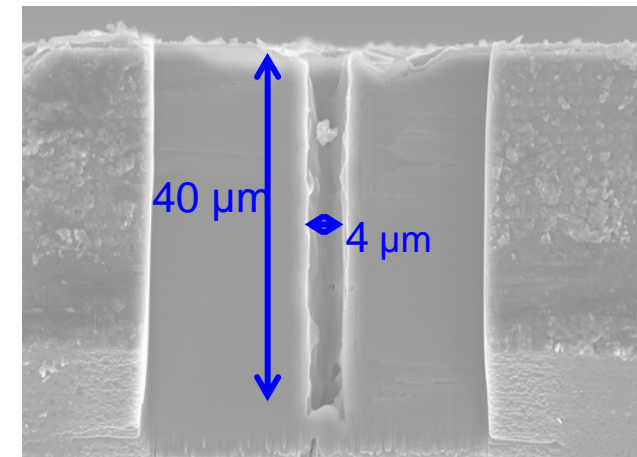
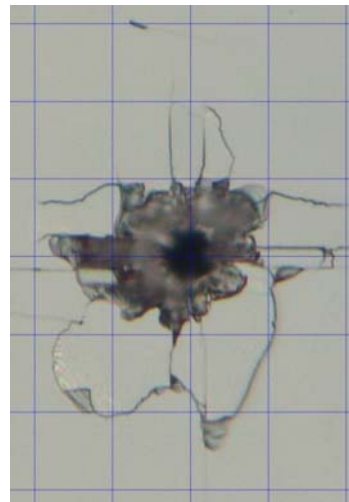
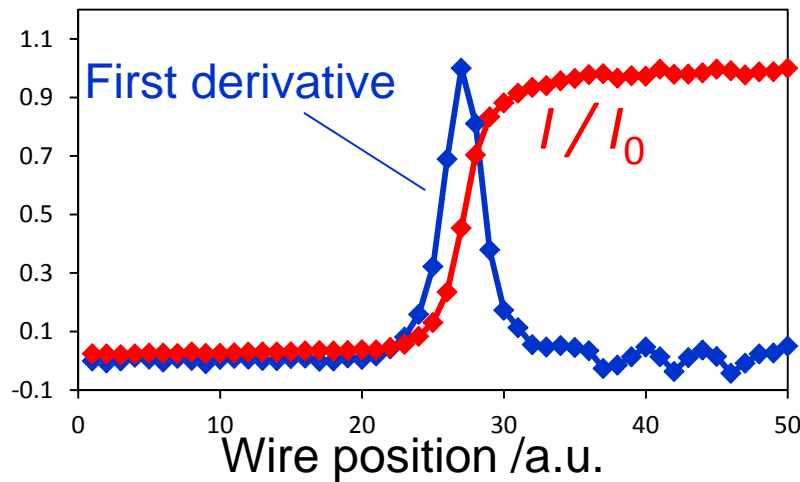
PUBLISHED ONLINE: 16 DECEMBER 2012 | DOI: 10.1038/NPHOTON.2012.306

### Focusing of X-ray free-electron laser pulses with reflective optics

Hirokatsu Yumoto<sup>1\*</sup>, Hidekazu Mimura<sup>2</sup>, Takahisa Koyama<sup>1</sup>, Satoshi Matsuyama<sup>3,4</sup>, Kensuke Tono<sup>1</sup>, Tadashi Togashi<sup>1</sup>, Yuichi Inubushi<sup>5</sup>, Takahiro Sato<sup>5</sup>, Takashi Tanaka<sup>5</sup>, Takashi Kimura<sup>6</sup>, Hikaru Yokoyama<sup>3</sup>, Jangwoo Kim<sup>3</sup>, Yasuhisa Sano<sup>3</sup>, Yousuke Hachisu<sup>7</sup>, Makina Yabashi<sup>5</sup>, Haruhiko Ohashi<sup>5</sup>, Hitoshi Ohmori<sup>7</sup>, Tetsuya Ishikawa<sup>5</sup> and Kazuto Yamauchi<sup>3,4,8</sup>

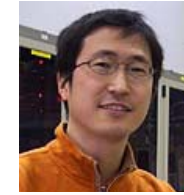
X-ray free-electron lasers<sup>1,2</sup> produce intense femtosecond pulses that have applications in exploring new frontiers in science. The unique characteristics of X-ray free-electron

To date, refractive<sup>10</sup>, diffractive<sup>3,11</sup> and reflective optics<sup>12</sup> have been developed to focus X-rays. Of these options, total reflective optics in the Kirkpatrick-Baez (K-B) geometry<sup>13</sup> which combines



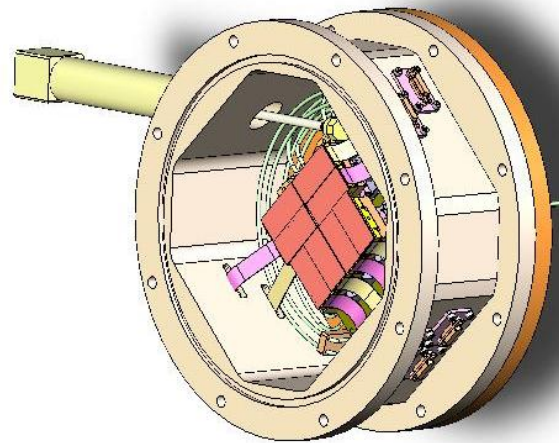
Koyama et al, OE 21, 15382 (2013)

# Detector



Kameshima (JASRI), Hatsui et al.,  
Rev. Sci. Instrum. 85 (2014)

- Multi-port CCD (MPCCD)
  - High sensitivity
  - Low noise
    - (single-photon detection capability)
  - Fast (60 fps)
  - Large area ( $\square 100$  mm)

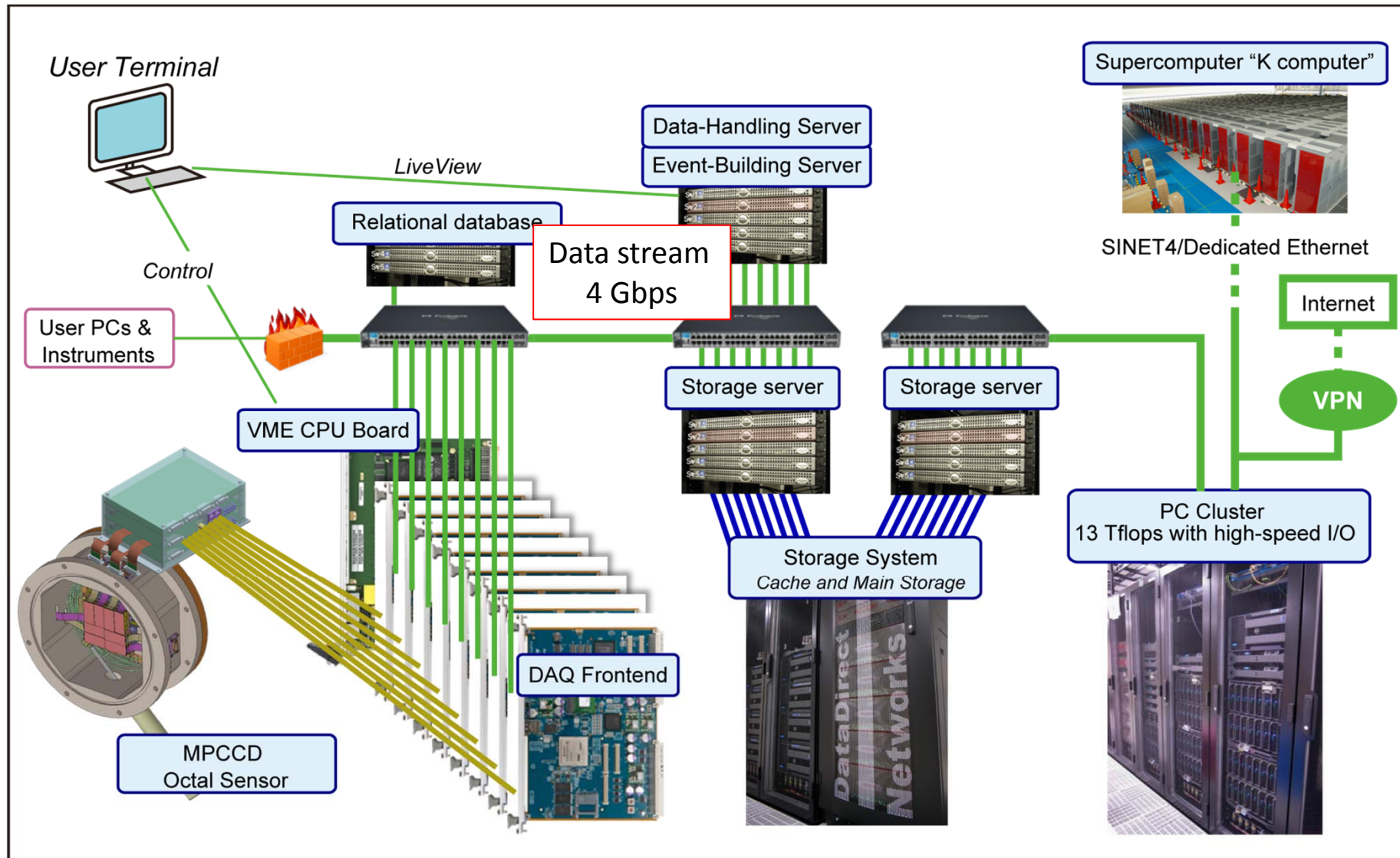


Octal Sensor Detector (100 x 100 mm)  
2048 x 2048 pixels

Specification	
Frame rate	$\geq 60$ fps
Pixel size	50 $\mu\text{m}$
Noise	300e <sup>-</sup>
Q.E.	$\sim 70\%$ @ 6 keV $\sim 20\%$ @ 12 keV
Dynamic range	14 bits
System noise	$< 0.2$ ph.@ 6 keV
Full well	$\sim 3000$ ph. @6keV $\sim 1500$ ph. @12keV

# Data acquisition (DAQ)

Joti, Kameshima (JASRI)  
Hatsui (RIKEN) et al.

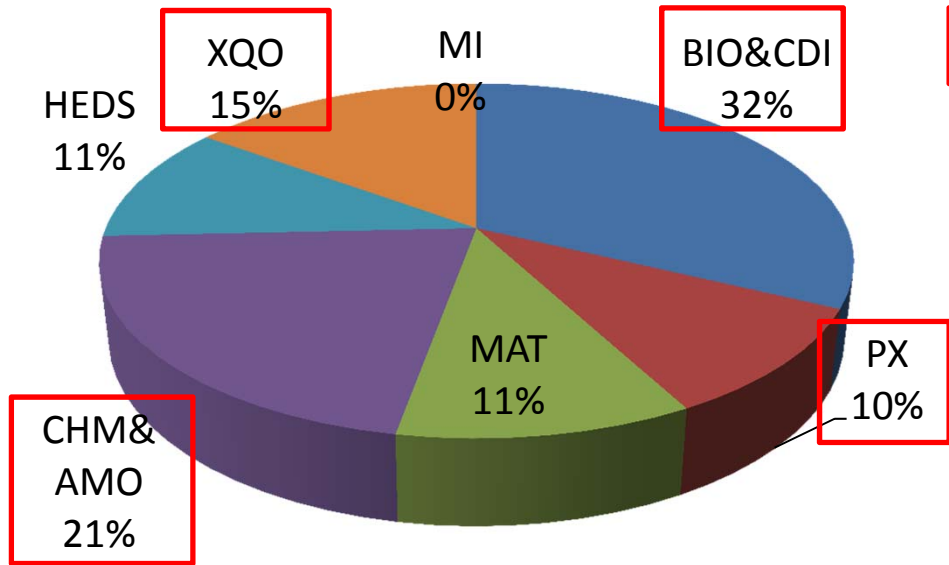


# Contents

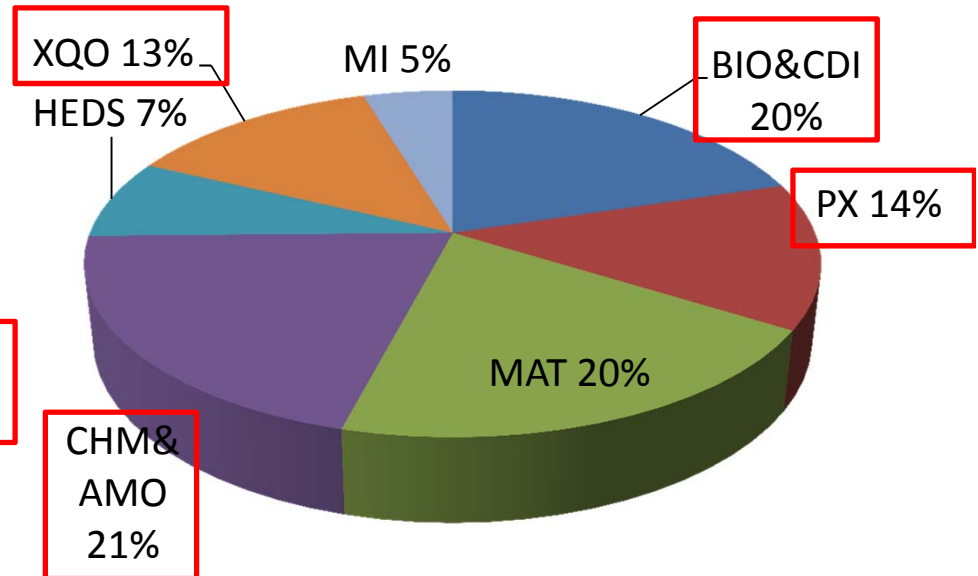
1. XFEL sciences
2. Photon beam properties
3. Photon beamline
4. Experimental stations
- 5. Experiments at SACLA**
  - Coherent diffraction imaging (CDI)
  - Femtosecond protein crystallography
  - Time-resolved X-ray absorption spectroscopy (XAS)
  - Nonlinear X-ray optics

# User experiments in FY2012&2013

## Term 2012A&B (280 shifts)



## Term 2013A&B (257 shifts)



**BIO&CDI:** Imaging biology & Coherent diffraction imaging

**PX:** Protein crystallography

**MAT:** Ultrafast materials science

**CHM&AMO:** Ultrafast chemistry & AMO science

**HEDS:** High energy density science

**XQO:** X-ray quantum optics

**MI:** Methods and instrumentation

# XFEL as a probe, as a trigger

- Observation in the “see-before-destruction” scheme.
  - Coherent diffraction imaging (CDI)
  - Femtosecond protein crystallography
- Observation of ultrafast phenomena
  - Time-resolved measurements
- Light-matter interaction under intense X-ray irradiation: XFEL as a trigger of novel optical phenomena
  - Nonlinear X-ray optics, X-ray amplification

# “See before destruction” (1)

## CDI for *single-particle* structure analysis

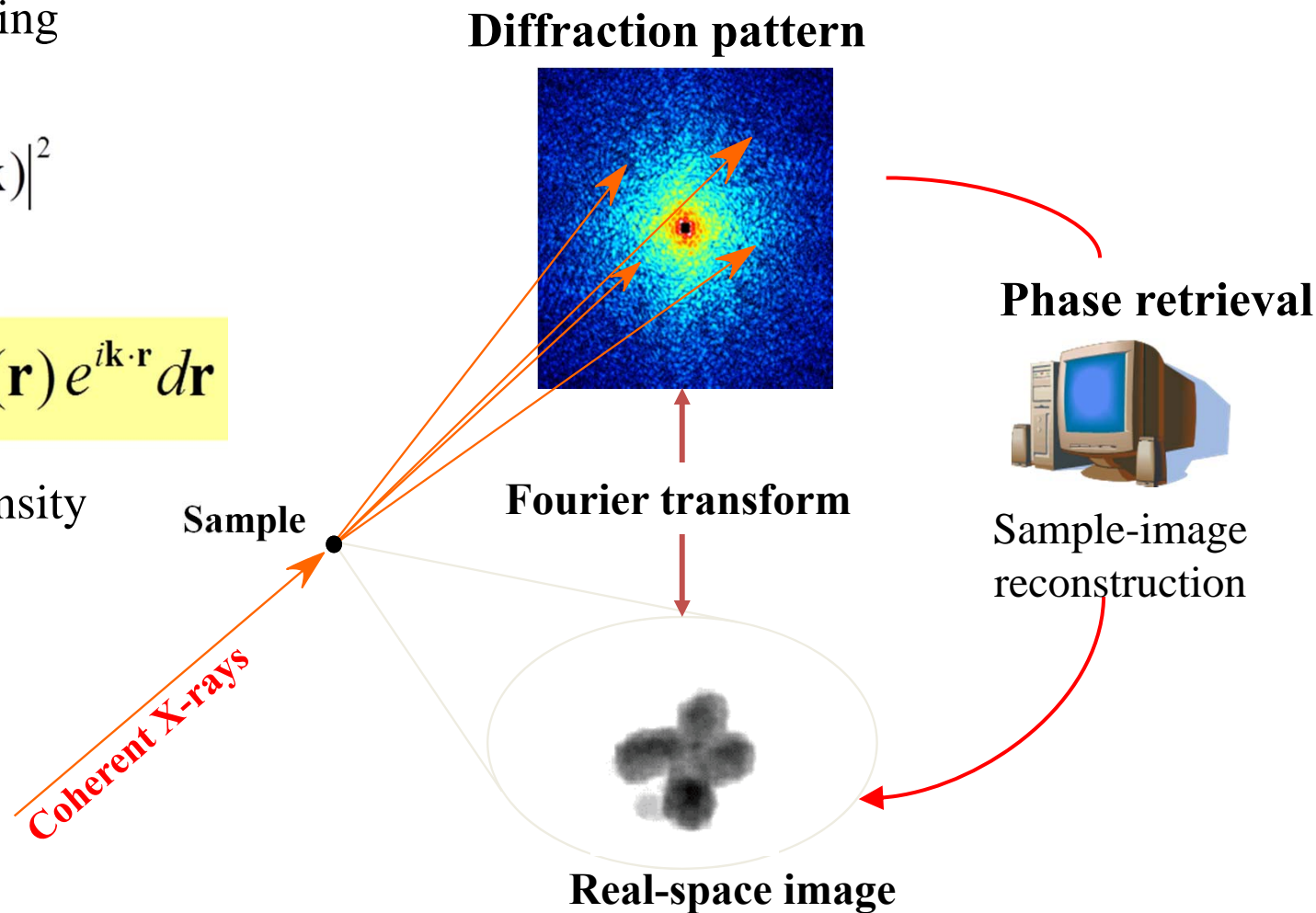
Differential scattering  
cross section

$$\frac{d\sigma}{d\Omega} = Pr_e^2 |F(\mathbf{k})|^2$$

Structure factor

$$F(\mathbf{k}) = \int \rho(\mathbf{r}) e^{i\mathbf{k}\cdot\mathbf{r}} d\mathbf{r}$$

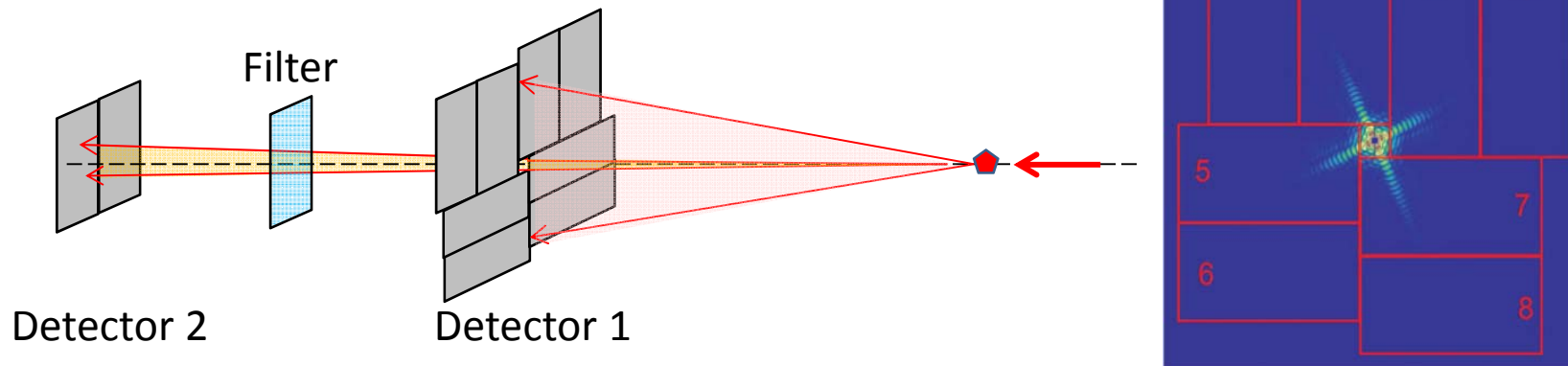
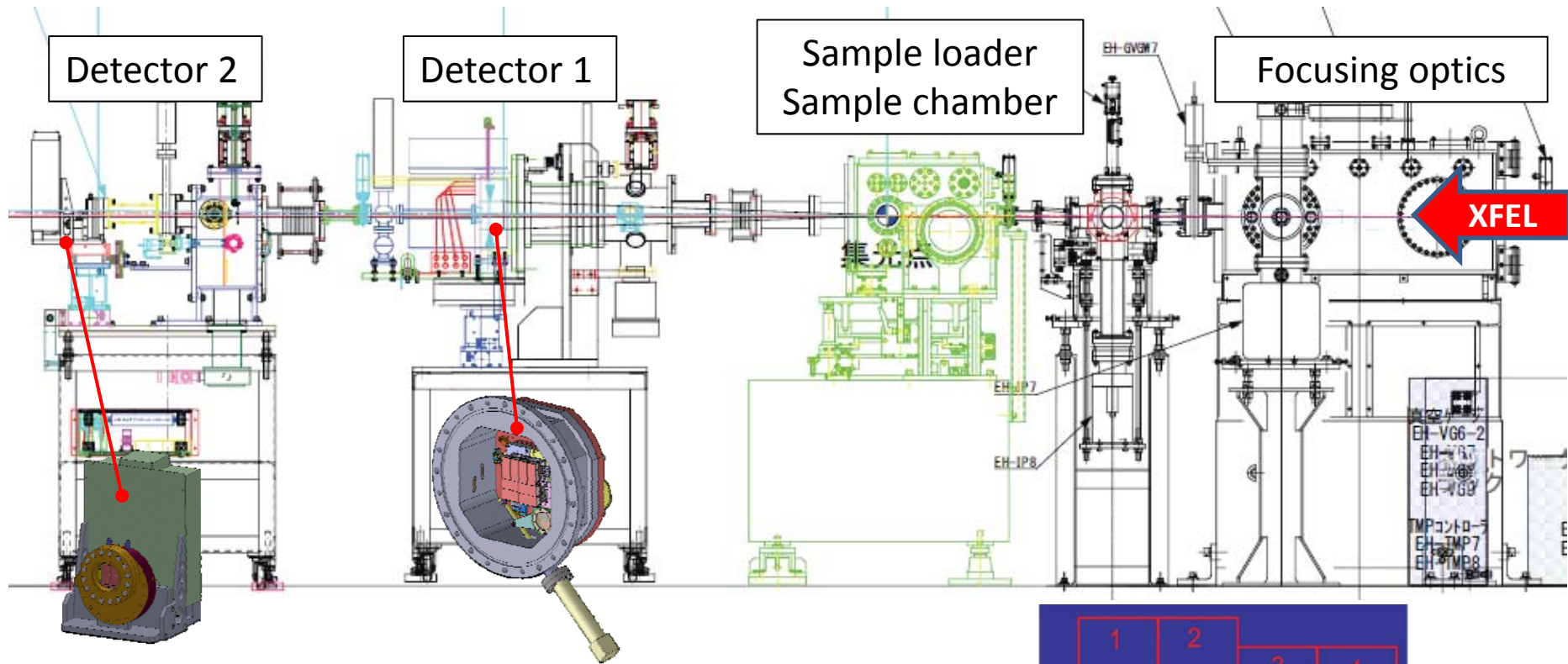
$\rho(\mathbf{r})$ : Electron density



Y. Nishino *et al.*, Phys. Rev. Lett **102**, 018101 (2009).

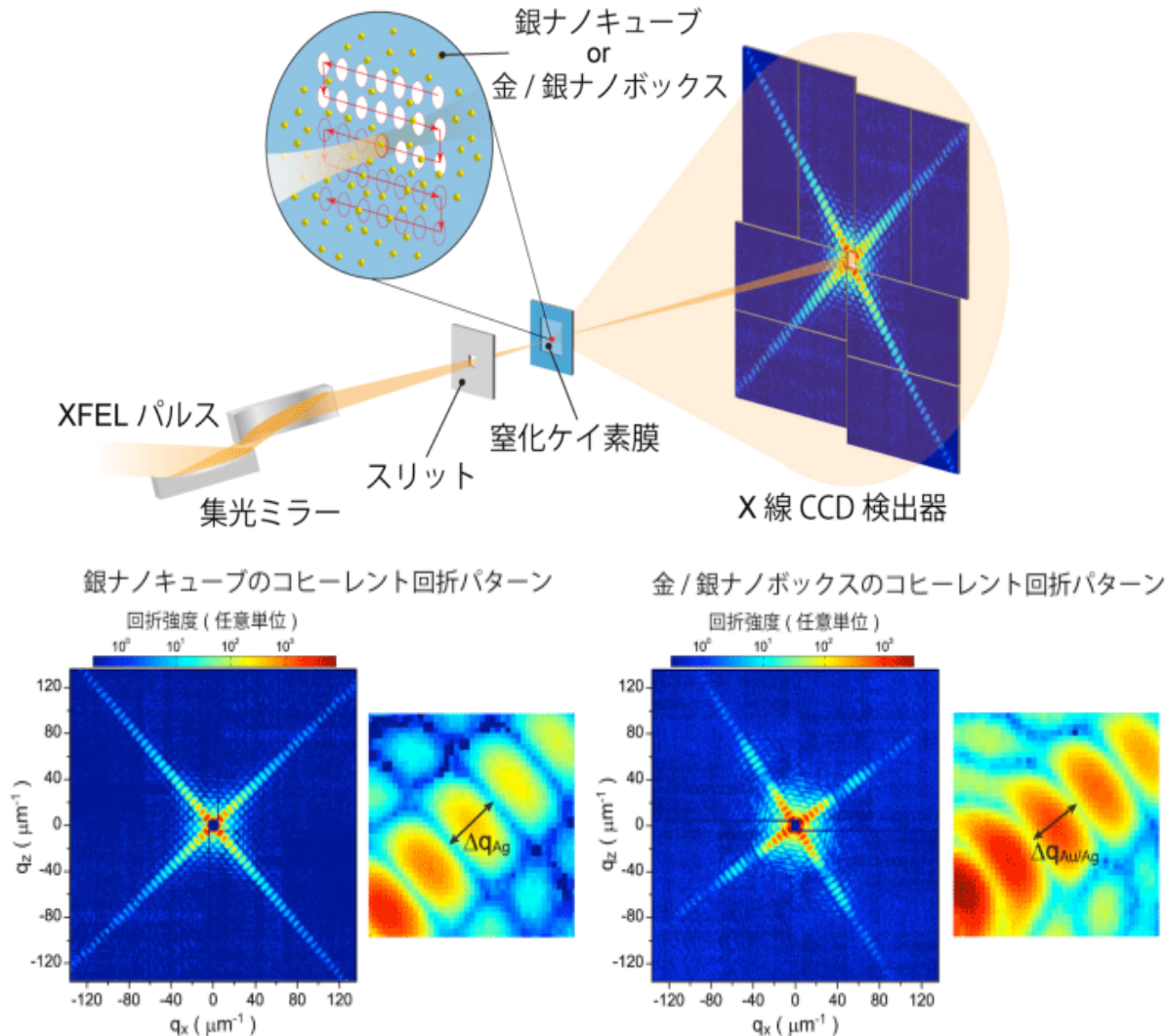


# Typical setup for CDI

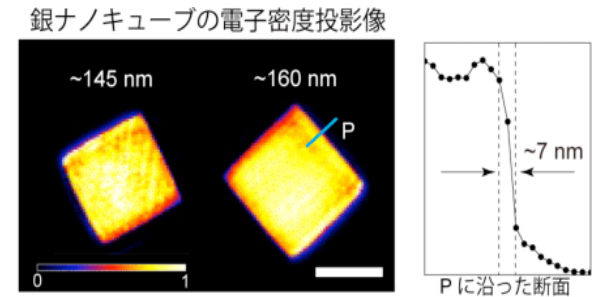


# CDI of nanomaterials

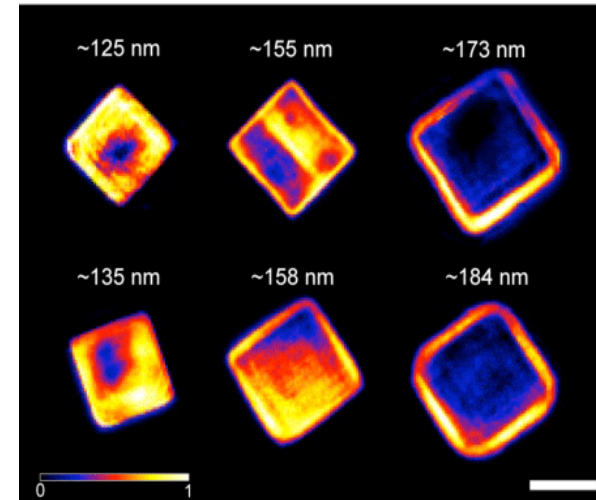
Takahashi et al., *Nano Lett.* **13**, 6028 (2013)



Resolution  $\sim 7$  nm

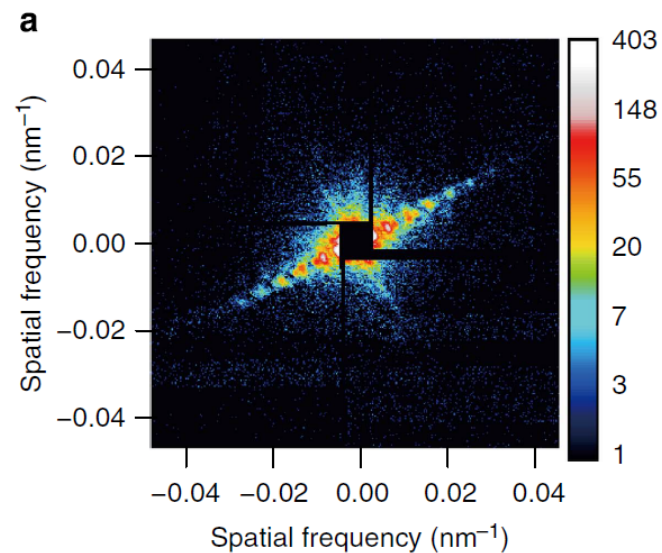
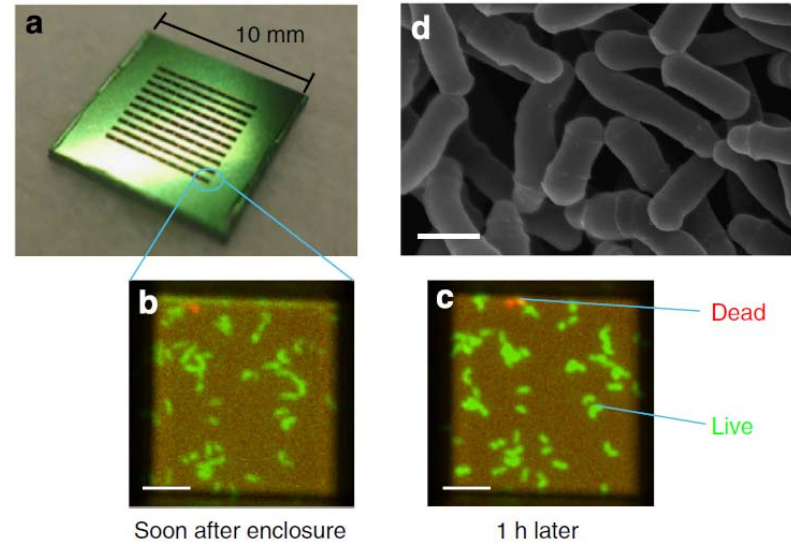
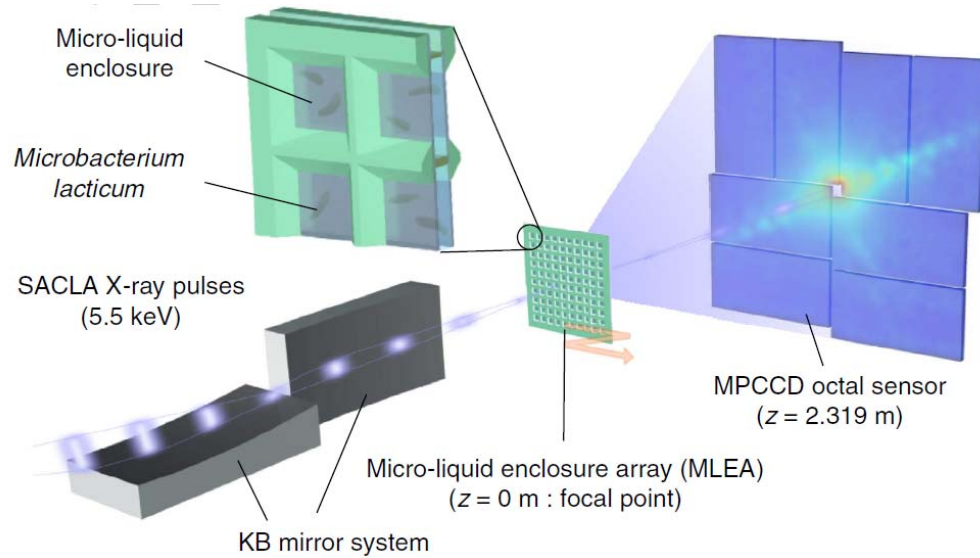


金/銀ナノボックスの電子密度投影像

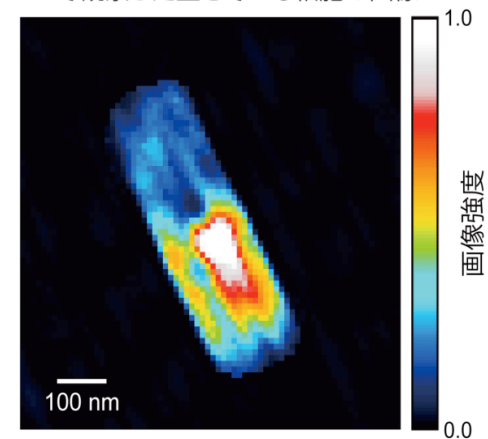


# CDI of live cell

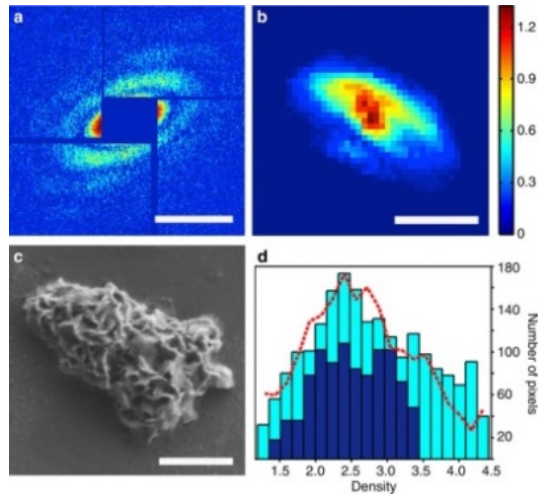
Kimura et al., *Nature Communications* 5, 3052 (2013).



XFELで観察した生きている細胞の画像

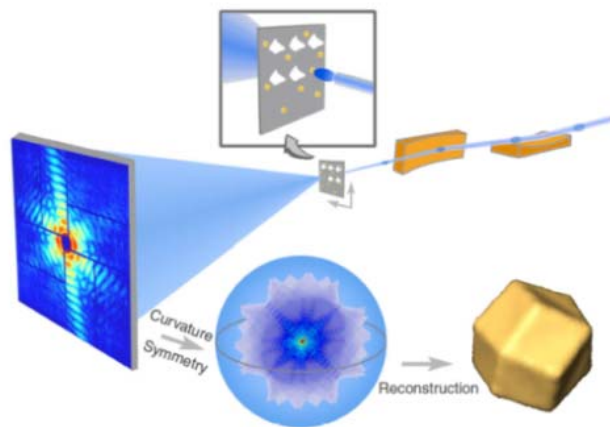


# And more



“Macromolecular structures probed by combining single-shot free-electron laser diffraction with synchrotron coherent X-ray imaging,”

M. Gallagher-Jones et al., *Nature Commun.* (2014)



“Single-shot three-dimensional structure determination of nanocrystals with femtosecond

X-ray free-electron laser pulses,”

R. Xu et al., *Nature Commun.* (2014)

# “See before destruction” (2)

## Femtosecond protein crystallography

- Damage free
  - Room temperature measurement
- Dynamics
  - Pump-probe capability
- Two major methods
  - For large, high-quality crystals
  - For small crystals

# Femtosecond crystallography

NATURE METHODS | VOL.11 NO.7 | JULY 2014 | 735

## Determination of damage-free crystal structure of an X-ray-sensitive protein using an XFEL

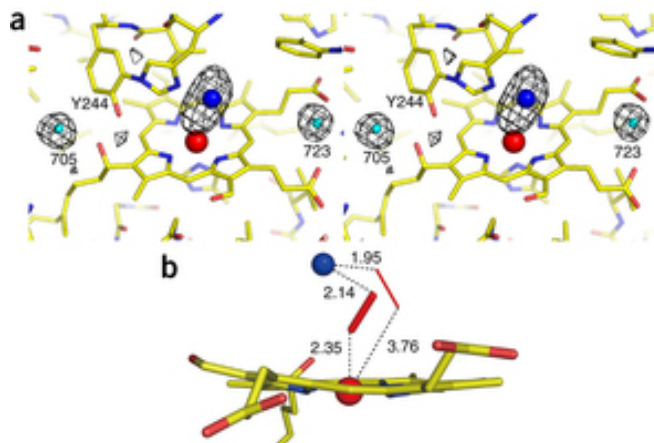
Kunio Hirata<sup>1,2,9</sup>, Kyoko Shinzawa-Itoh<sup>3,9</sup>, Naomine Yano<sup>2,3</sup>, Shuhei Takemura<sup>3</sup>, Koji Kato<sup>3,8</sup>, Miki Hatanaka<sup>3</sup>, Kazumasa Muramoto<sup>3</sup>, Takako Kawahara<sup>3</sup>, Tomitake Tsukihara<sup>2-4</sup>, Eiki Yamashita<sup>4</sup>, Kensuke Tono<sup>5</sup>, Go Ueno<sup>1</sup>, Takaaki Hikima<sup>1</sup>, Hironori Murakami<sup>1</sup>, Yuichi Inubushi<sup>1</sup>, Makina Yabashi<sup>1</sup>, Tetsuya Ishikawa<sup>1</sup>, Masaki Yamamoto<sup>1</sup>, Takashi Ogura<sup>6</sup>, Hiroshi Sugimoto<sup>1</sup>, Jian-Ren Shen<sup>7</sup>, Shinya Yoshikawa<sup>3</sup> & Hideo Ago<sup>1</sup>

Hirata et al., *Nature Methods* 7, 735 (2014).

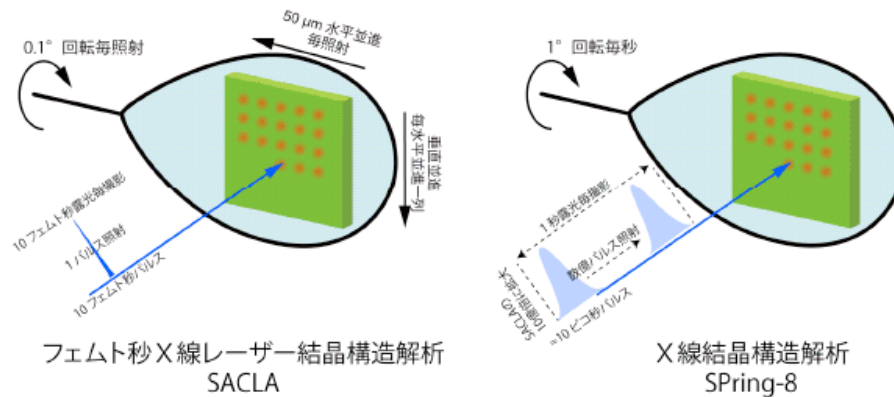
a



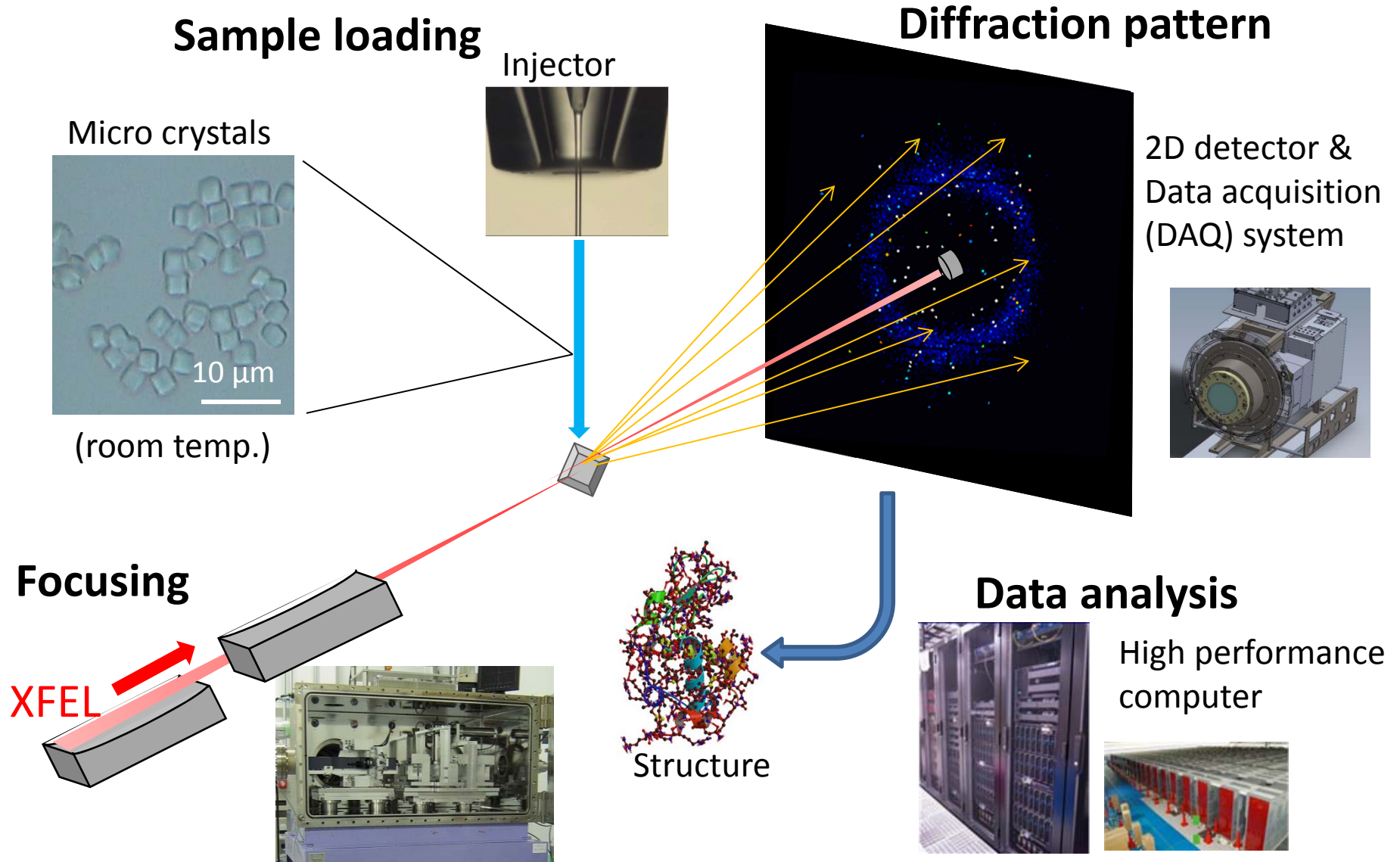
## Damage-free structure



b

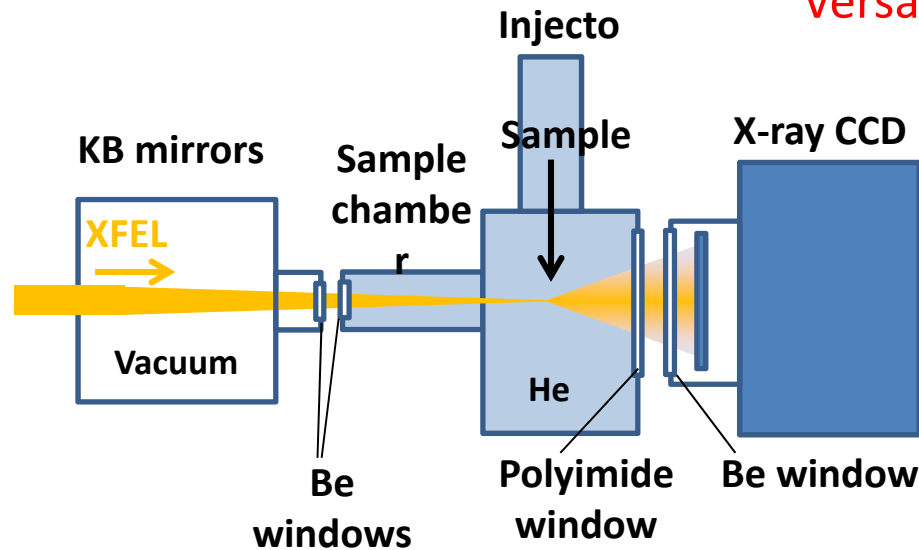


# Serial femtosecond crystallography (SFX)

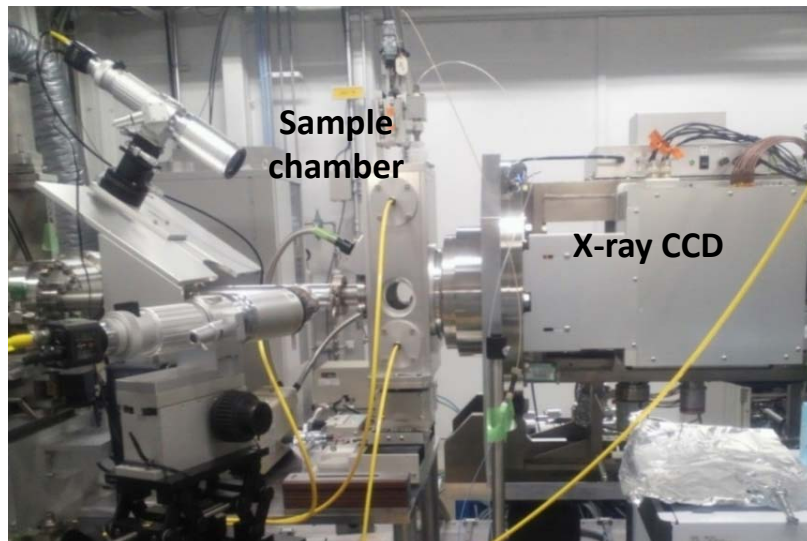


# DAPHNIS (Diverse Application Platform for Hard x-ray diffraction In SACLA )

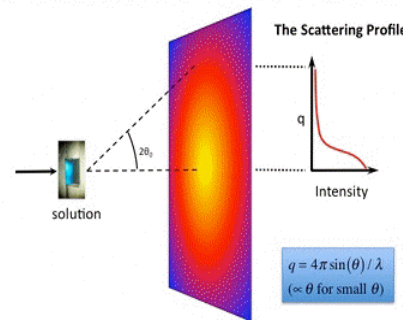
Versatile platform for SFX (diffraction/scattering)



- Components are separated to be handled easily.
- Operated under atmospheric pressure (He atmosphere)
- Flexible system adaptable to various sample injectors
- Extensible to pump-probe measurement



Also applicable to diffraction & scattering experiments for variety of solution and solid samples with P&P capability.



solution scattering

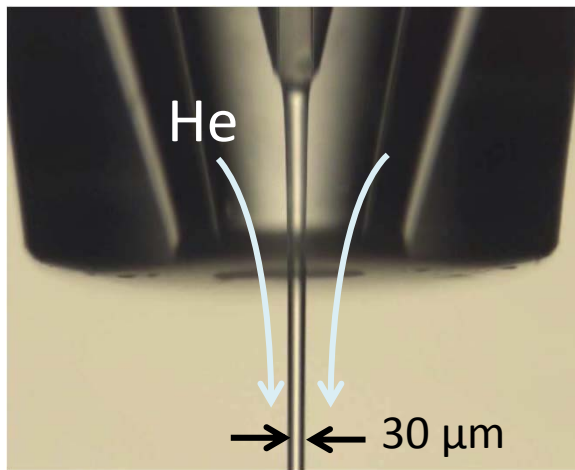


powder diffraction



# Fluid injectors

Continuous beam



Flow rate =  $\sim 0.4$  mL/min

Proteins:  $\sim 100$  mg

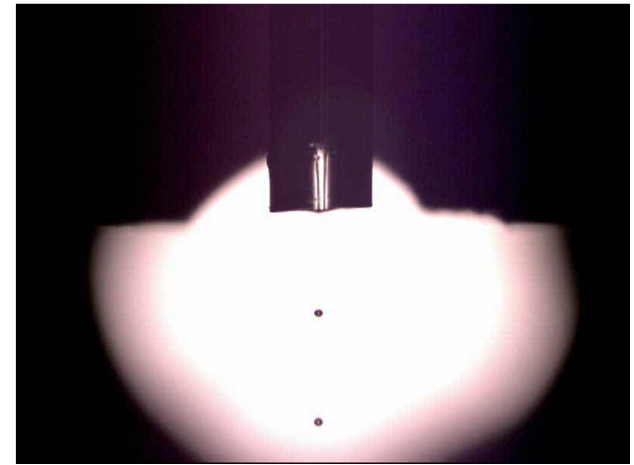
High-viscosity sample



$\sim 0.5$   $\mu$ L/min

Proteins:  $\sim 0.1$  mg

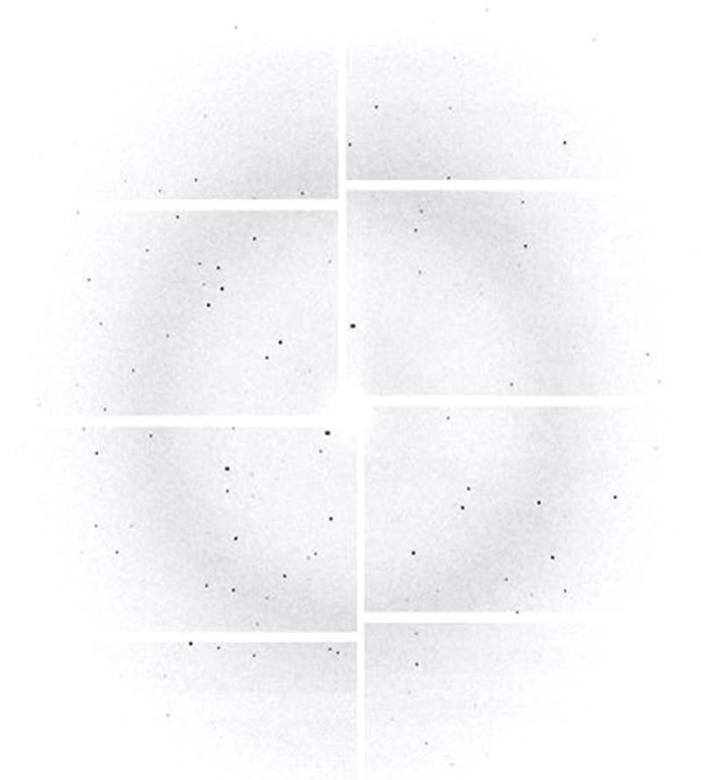
Droplets



$\sim 0.1$   $\mu$ L/min

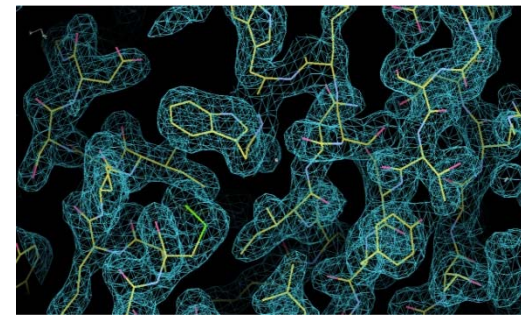
Proteins:  $< 0.1$  mg

# Single-shot diffraction patterns of Lysozyme



Lysozyme  
(Average crystal size:  $\sim 5 \mu\text{m}$ )

Electron density map



Resolution  $< 2 \text{ \AA}$

## Statistics

Shot number: 70,000

Number of Images with diffraction spots : 21723 (Hit rate: 31%)

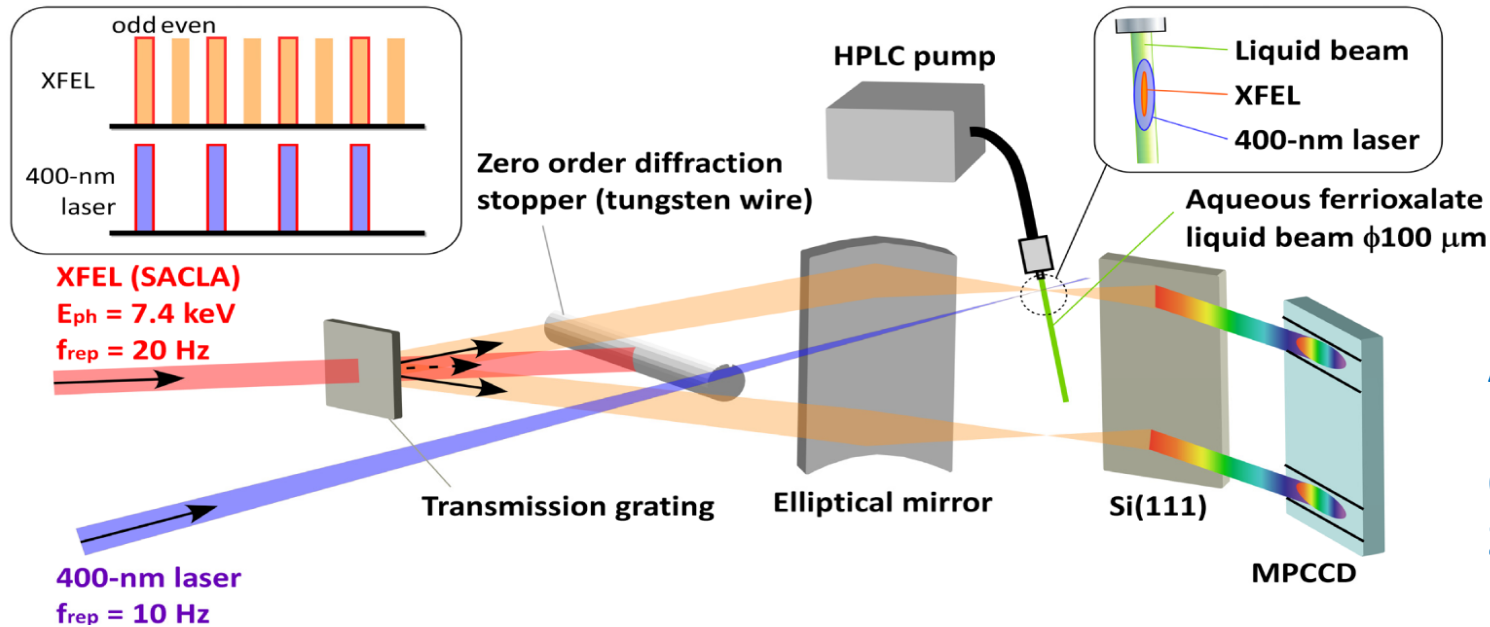
Indexable images: 13,912 (20%)

Measurement time: 1 hour (20 Hz)

# Time-resolved measurements for probing ultrafast phenomena

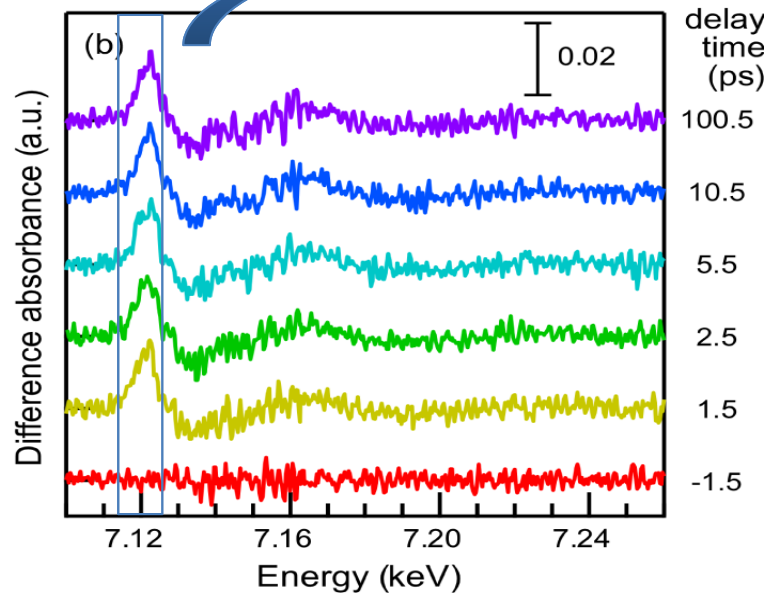
- Time-resolved X-ray absorption/emission spectroscopy (XAS/XES)
- Time-resolved X-ray diffraction/scattering
- Time-resolved photoelectron spectroscopy
- Ultrafast probe for high energy density sciences
  - Laser shock compression of materials
  - Ultrafast probe of plasma

# Time-resolved XAS for ultrafast chemistry

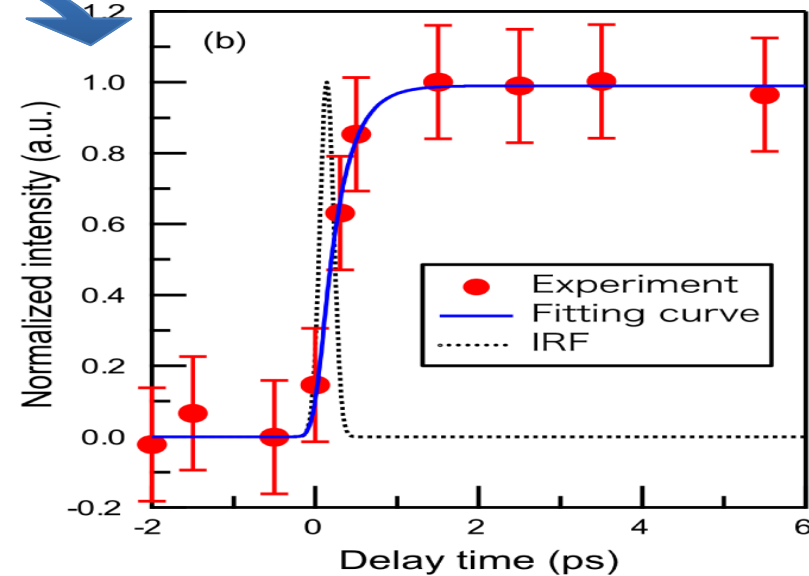


Katayama et al,  
 APL **103**,  
 131105  
 Obara et al, OE  
**22**, 1105 (2014)

**Differential spectrum**



**Temporal evolution**



# Light-matter interaction under intense X-ray irradiation

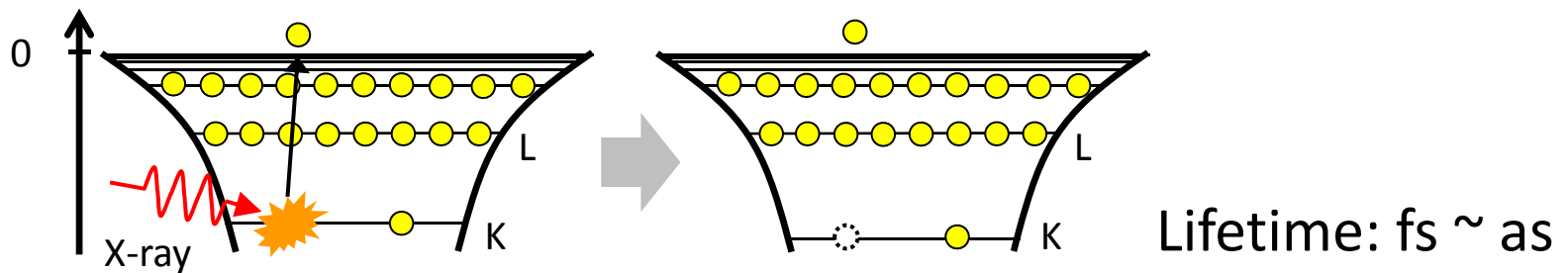
- Nonlinear X-ray optics
  - Multi-photon processes
  - Novel optical responses in the X-ray region
  - X-ray amplification

# Nonlinear phenomena via interaction with intense XFEL

Intense XFEL pulse interacts with atoms within a time scale comparable to a core-hole lifetime.



- *Multi-photons* can be involved.
- Core<sub>E</sub>hole atoms can contribute to optical phenomena.



## Nonlinear phenomena associated with core-hole atoms

- Double core-hole generation
- Two-photon absorption
- Saturable absorption
- Amplification of x-ray pulse

# To obtain enough XFEL intensity for nonlinear phenomena

XFEL intensity

$$I = \frac{E}{S \cdot \tau} \quad (\text{W/cm}^2)$$

Pulse energy  $\sim 10^{-4}$  J

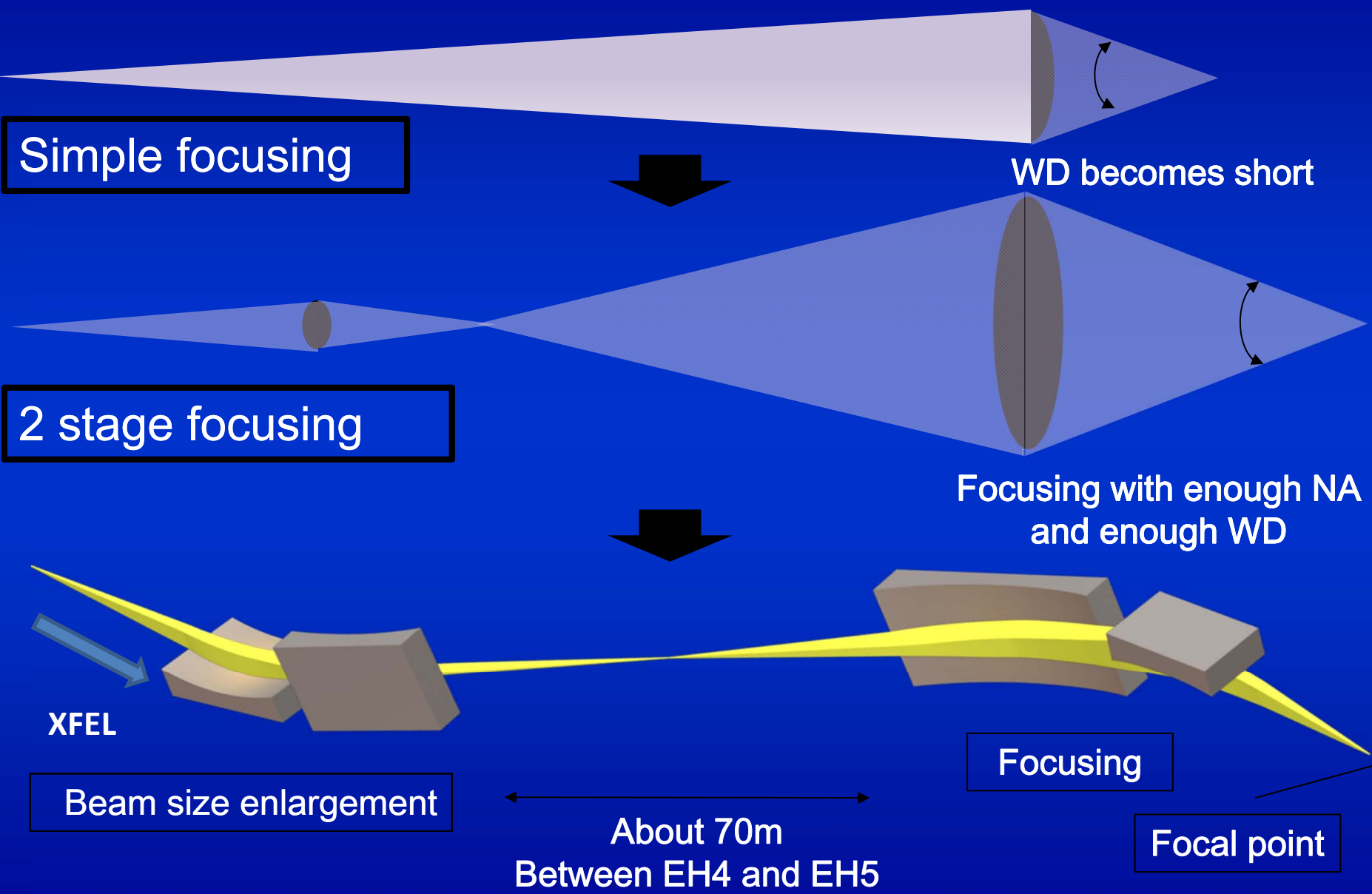
Focal spot  $\sim 10^{-10}$  cm<sup>2</sup> (= 100 nm x 100 nm)

Pulse duration  $\sim 10^{-14}$  s

The diagram illustrates the equation for XFEL intensity,  $I = \frac{E}{S \cdot \tau}$  (W/cm<sup>2</sup>). The variables are annotated with their typical values: Pulse energy  $\sim 10^{-4}$  J (green oval), Focal spot  $\sim 10^{-10}$  cm<sup>2</sup> (= 100 nm x 100 nm) (blue oval), and Pulse duration  $\sim 10^{-14}$  s (red oval). Arrows point from each annotation to its corresponding variable in the equation.

**Focusing XFEL down to < 100 nm, an intensity reaches  $10^{20}$  W/cm<sup>2</sup>**

# 2-stage focusing for creating nanometer spot

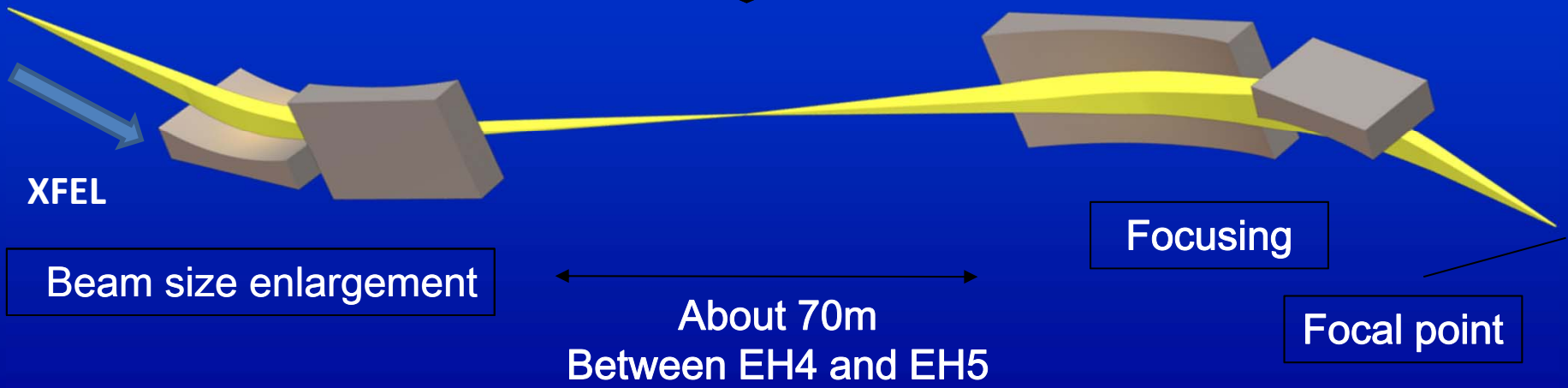


Simple focusing

WD becomes short

2 stage focusing

Focusing with enough NA and enough WD



XFEL

Beam size enlargement

About 70m  
Between EH4 and EH5

Focusing

Focal point



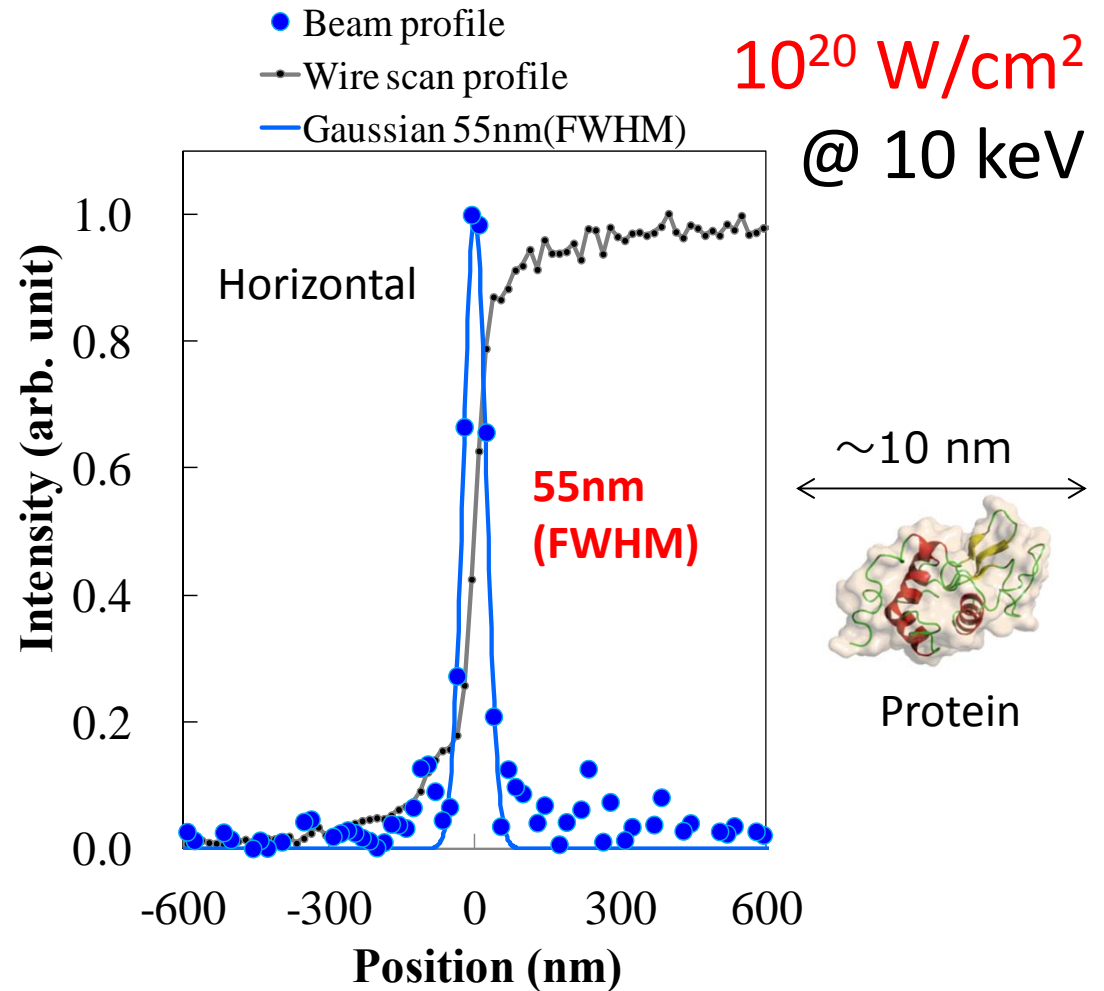
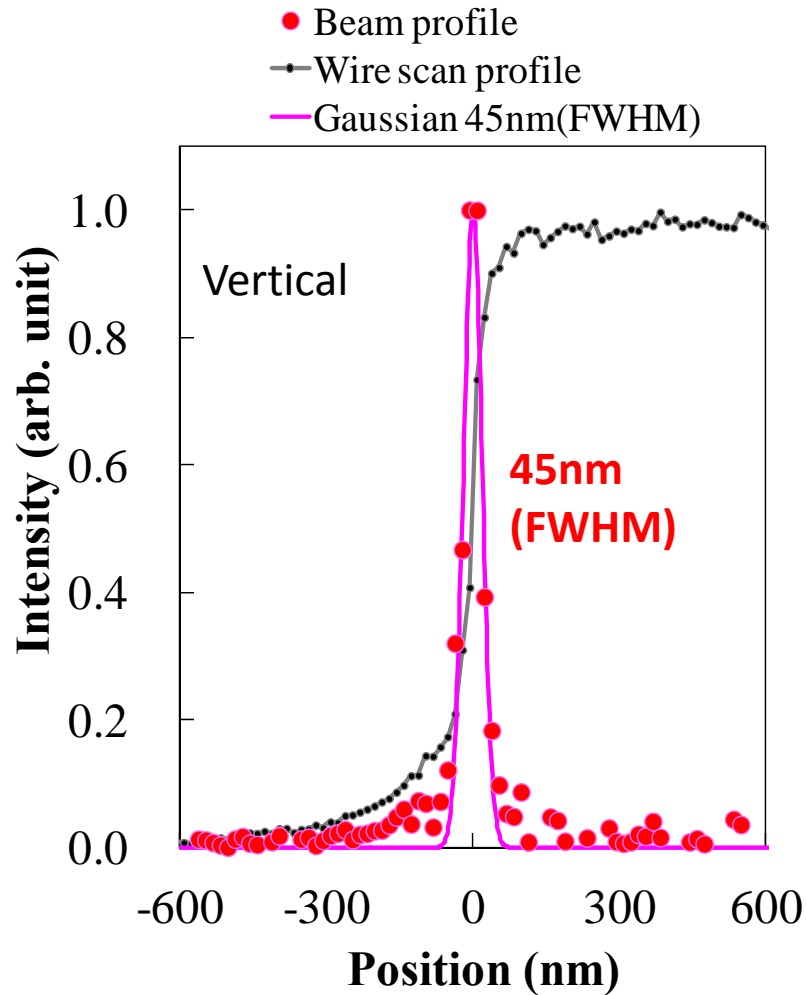
# Results

Mimura et al,  
Nature Comm., DOI: 10.1038/ncomms 4539 (2014)

nature  
COMMUNICATIONS

ARTICLE  
Received 17 Sep 2013 | Accepted 4 Mar 2014 | Published 30 Apr 2014  
DOI: 10.1038/ncomms4539

Generation of  $10^{20} \text{ W cm}^{-2}$  hard X-ray laser pulses with two-stage reflective focusing system

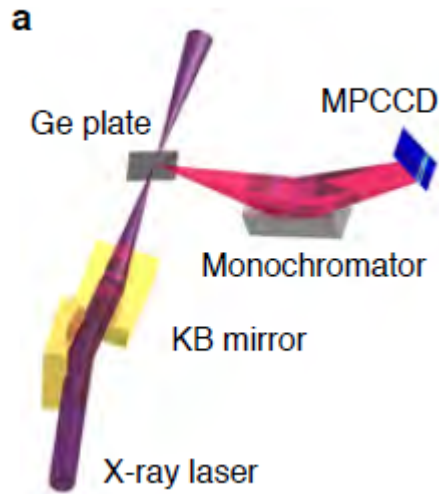


# Application: Two-photon absorption

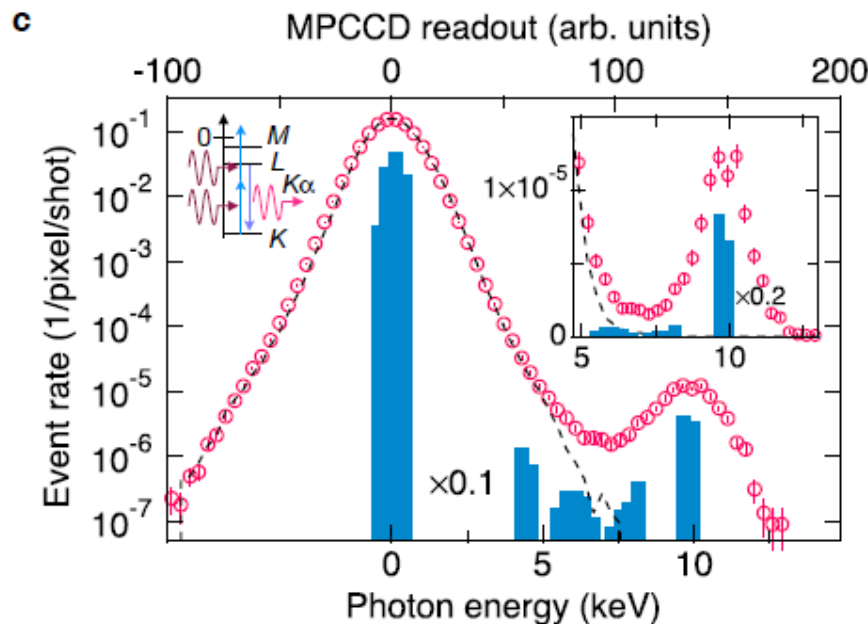


Tamasaku-san  
Nature Photon  
(2014)

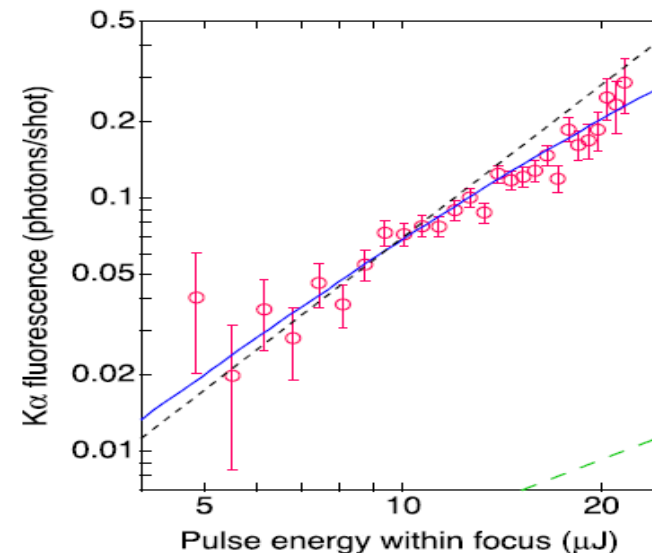
50 nm focusing  $\Rightarrow \sim 10^{20}$  W/cm<sup>2</sup>



K-shell core-hole of Ge (absorption edge: 11.1 keV) is created by absorption of **two 5.6-keV photons**



Intensity dependence: close to quadratic



# Summary

- Novel properties and sciences of XFEL
  - Ultra-brilliant, ultra-short, and coherent
  - Beyond static, statistical, perturbative pictures
- Beamline for XFEL
  - Damage-free & speckle-free optics
  - Single-shot, nondestructive diagnostics
- Experimental instrumentation for single-shot measurement
  - focusing optics, sample injectors, detectors, DAQ system, femtosecond laser
- Experiments at SACLA
  - Femtosecond snapshots of samples
  - Damage-free crystallography
  - X-ray-matter interaction under ultra-high photon flux
  - Pump-probe measurement

# Outlook

- Upgrade of SACLA
  - Self seeding
  - Multi-beamline operation (BL1, BL2, BL3)
- New instruments
  - Ultimate focusing
  - High power lasers
  - Detector upgrade